

## 2-SERIES, 3-SERIES, AND 4-SERIES CELL LITHIUM-ION OR LITHIUM-POLYMER BATTERY PROTECTION AFE

Check for Samples: [bq29330](#)

### FEATURES

- 2-Series, 3-Series, or 4-Series Cell Protection Control
- Can Directly Interface with the bq803x-Based Gas Gauge Family
- Watchdog and POR for the Host
- Provides Individual Cell Voltages and Battery Voltage to Battery Management Host
- Capable of Operation With 5-mΩ Sense Resistor Integrated Cell Balancing Drive
- I<sup>2</sup>C Compatible User Interface Allows Access to Battery Information
- Programmable Threshold and Delay for Overload Short Circuit in Discharge and Short Circuit in Charge
- NMOS FET Drive for Charge and Discharge FETs
- Host Control can Initiate Sleep and Ship Power Modes
- Integrated 2.5-V, 16-mA LDO
- Integrated 3.3-V, 25-mA LDO
- Supply Voltage Range from 4.5 V to 28 V
- Low Supply Current of 100 μA Typical

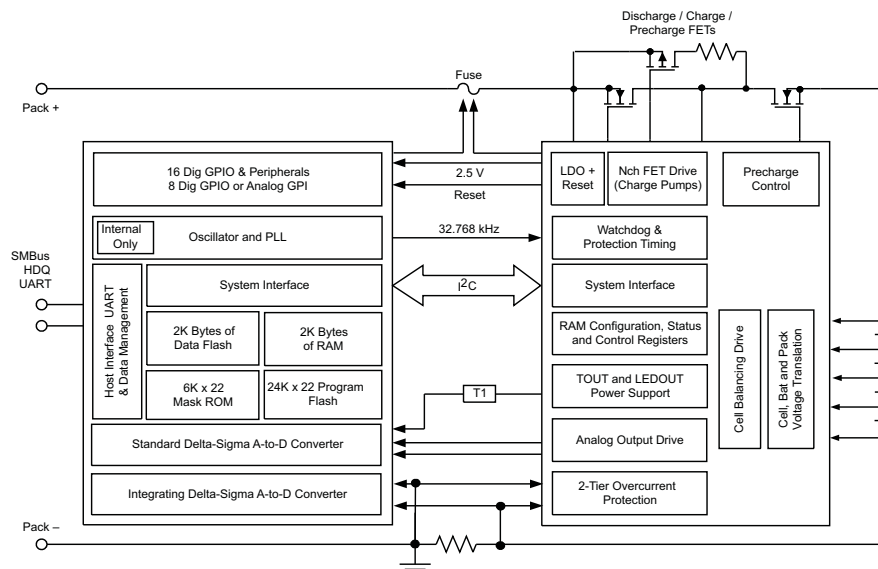
### APPLICATIONS

- Notebook Computers
- Medical and Test Equipment
- Instrumentation and Measurement Systems

### DESCRIPTION

The bq29330 is a 2-series, 3-series, and 4-series cell lithium-ion battery pack full-protection analog front end (AFE) IC that incorporates a 2.5-V, 16-mA and 3.3-V, 25-mA low dropout regulator (LDO). The bq29330 also integrates an I<sup>2</sup>C-compatible interface to extract battery parameters such as battery voltage, individual cell voltages, and control output status. Other parameters such as current protection thresholds and delays can also be programmed into the bq29330 to increase the flexibility of the battery management system.

### SYSTEM DIAGRAM



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## DESCRIPTION (CONTINUED)

The bq29330 provides safety protection for overload, short circuit in charge, and short circuit in discharge conditions and can also provide cell overvoltage, battery overvoltage and battery undervoltage protection with the battery management host. In overload, short circuit in charge and short circuit in discharge conditions, the bq29330 turns off the FET drive autonomously, depending on the internal configuration setting. The communications interface allows the host to observe and control the status of the bq29330, enable cell balancing, enter different power modes, set current protection levels, and set the blanking delay times.

Cell balancing of each cell can be performed via a cell bypass path integrated into the bq29330, which can be enabled via the internal control register accessible via the I<sup>2</sup>C-compatible interface. The maximum bypass current is set via an external series resistor and internal FET on resistance (typ. 400  $\Omega$ ).

## ORDERING INFORMATION<sup>(1)</sup>

| T <sub>A</sub> | PACKAGE                   |                         |
|----------------|---------------------------|-------------------------|
|                | TSSOP(DBT) <sup>(2)</sup> | QFN(RSM) <sup>(2)</sup> |
| –40°C to 110°C | bq29330DBT                | bq29330RSM              |

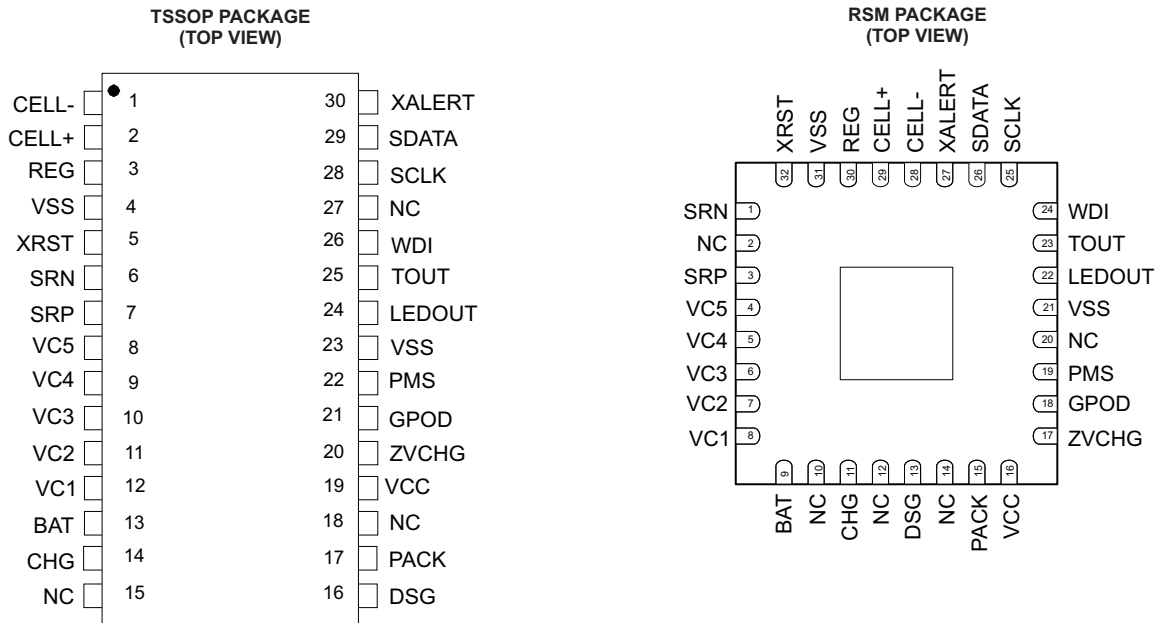
- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at [www.ti.com](http://www.ti.com).  
 (2) The bq29330 can be ordered in tape and reel by adding the suffix R to the orderable part number, i.e., bq29330DBTR.

## THERMAL INFORMATION

| THERMAL METRIC <sup>(1)</sup> |                                              | bq29330     |           | UNITS |
|-------------------------------|----------------------------------------------|-------------|-----------|-------|
|                               |                                              | TSSOP (DBT) | QFN (RSM) |       |
|                               |                                              | 30 PINS     | 32 PINS   |       |
| $\theta_{JA}$ , High K        | Junction-to-ambient thermal resistance       | 81.4        | 37.4      | °C/W  |
| $\theta_{JC(top)}$            | Junction-to-case(top) thermal resistance     | 16.2        | 30.6      |       |
| $\theta_{JB}$                 | Junction-to-board thermal resistance         | 34.1        | 7.7       |       |
| $\Psi_{JT}$                   | Junction-to-top characterization parameter   | 0.4         | 0.4       |       |
| $\Psi_{JB}$                   | Junction-to-board characterization parameter | 33.6        | 7.5       |       |
| $\theta_{JC(bottom)}$         | Junction-to-case(bottom) thermal resistance  | N/A         | 2.6       |       |

- (1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](http://www.ti.com/lit/an/spra953).

## PACKAGE OPTION PIN DIAGRAMS



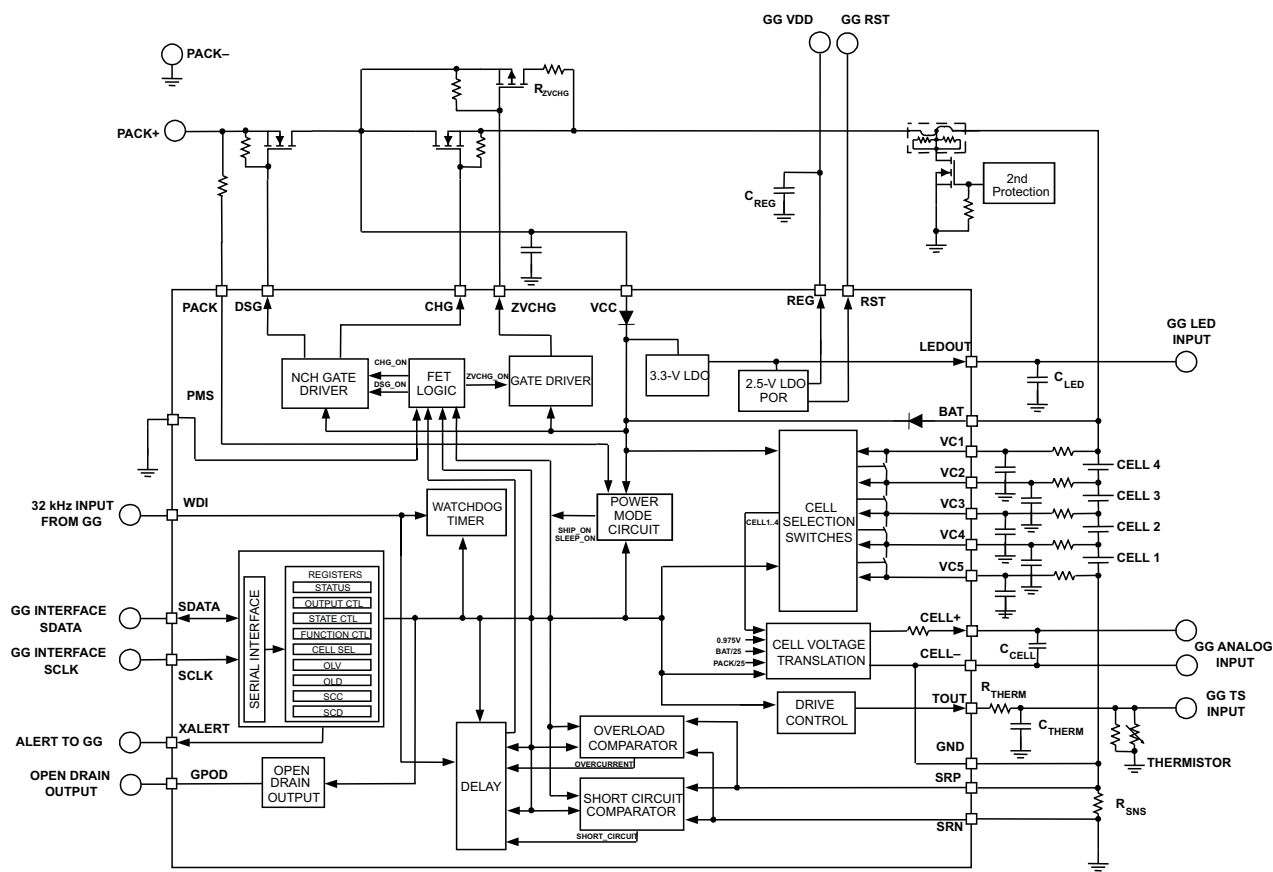
## PIN FUNCTIONS

| PIN    |         |         | DESCRIPTION                                                                                                                                                              |
|--------|---------|---------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME   | DBT NO. | RSM NO. |                                                                                                                                                                          |
| CELL–  | 1       | 28      | Output of scaled value of the measured cell voltage.                                                                                                                     |
| CELL+  | 2       | 29      | Output of scaled value of the measured cell voltage.                                                                                                                     |
| REG    | 3       | 30      | Integrated 2.5-V regulator output                                                                                                                                        |
| VSS    | 4, 23   | 31,21   | Power supply ground                                                                                                                                                      |
| XRST   | 5       | 32      | Active-low output                                                                                                                                                        |
| SRN    | 6       | 1       | Current sense terminal                                                                                                                                                   |
| SRP    | 7       | 3       | Current sense positive terminal when charging relative to SRN; current sense negative terminal when discharging relative to SRN                                          |
| VC5    | 8       | 4       | Sense voltage input terminal for most negative cell; balance current input for least positive cell.                                                                      |
| VC4    | 9       | 5       | Sense voltage input terminal for least positive cell, balance current input for least positive cell, and return balance current for third most positive cell.            |
| VC3    | 10      | 6       | Sense voltage input terminal for third most positive cell, balance current input for third most positive cell, and return balance current for second most positive cell. |
| VC2    | 11      | 7       | Sense voltage input terminal for second most positive cell, balance current input for second most positive cell, and return balance current for most positive cell.      |
| VC1    | 12      | 8       | Sense voltage input terminal for most positive cell, balance current input for most positive cell, and battery stack measurement input                                   |
| BAT    | 13      | 9       | Device power supply input                                                                                                                                                |
| CHG    | 14      | 11      | Charge pump, charge N-CH FET gate drive                                                                                                                                  |
| DSG    | 16      | 13      | Charge pump output, discharge N-CH FET gate drive                                                                                                                        |
| PACK   | 17      | 15      | PACK positive terminal and alternative power source                                                                                                                      |
| VCC    | 19      | 16      | Power supply voltage                                                                                                                                                     |
| ZVCHG  | 20      | 17      | Connect the precharge P-CH FET drive here                                                                                                                                |
| GPOD   | 21      | 18      | NCH FET open-drain output                                                                                                                                                |
| PMS    | 22      | 19      | Determines CHG output state on POR                                                                                                                                       |
| LEDOUT | 24      | 22      | 3.3-V output for LED display power supply                                                                                                                                |
| TOUT   | 25      | 23      | Provides thermistor bias current                                                                                                                                         |

**PIN FUNCTIONS (continued)**

| PIN    |          |                   | DESCRIPTION                                                                                                         |
|--------|----------|-------------------|---------------------------------------------------------------------------------------------------------------------|
| NAME   | DBT NO.  | RSM NO.           |                                                                                                                     |
| WDI    | 26       | 24                | Digital input that provides the timing clock for the OC and SC delays and also acts as the watchdog clock.          |
| SCLK   | 28       | 25                | Open-drain serial interface clock with internal 10-k $\Omega$ pullup to V <sub>REG</sub>                            |
| SDATA  | 29       | 26                | Open-drain bidirectional serial interface data with internal 10-k $\Omega$ pullup to V <sub>REG</sub>               |
| XALERT | 30       | 27                | Open-drain output used to indicate status register changes. With internal 100-k $\Omega$ pullup to V <sub>REG</sub> |
| NC     | 15,18,27 | 2, 10, 12, 14, 20 | Not electrically connected to the IC                                                                                |

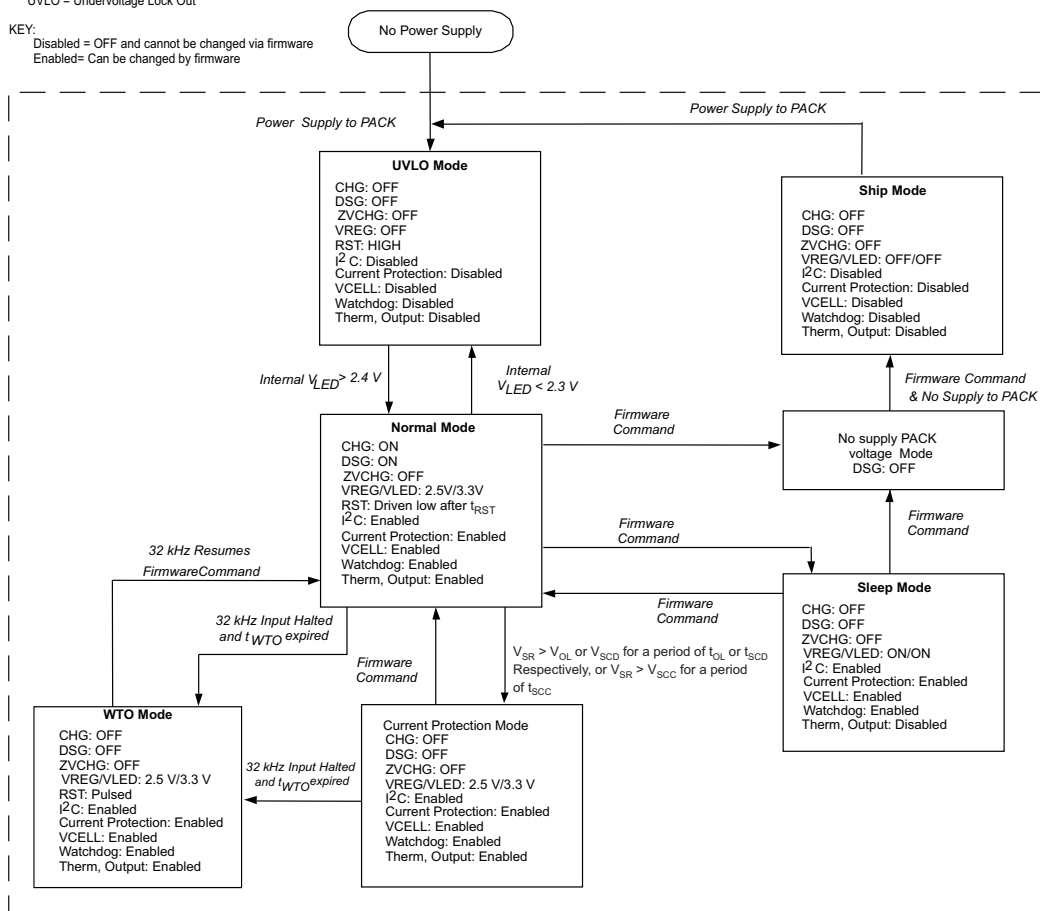
**FUNCTIONAL BLOCK DIAGRAM**



## SAFETY STATE DIAGRAM

LEGEND:  
UVLO = Undervoltage Lock Out

KEY:  
Disabled = OFF and cannot be changed via firmware  
Enabled = Can be changed by firmware



## ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)<sup>(1) (2)</sup>

|                                             |                                                  | <b>bq29330</b> | <b>UNIT</b> |
|---------------------------------------------|--------------------------------------------------|----------------|-------------|
| Supply voltage range                        | (VCC, BAT)                                       | –0.3 to 34     | V           |
| Input voltage range                         | (VC1, VC2, VC3, VC4, PACK, PMS)                  | –0.3 to 34     |             |
|                                             | (VC5)                                            | –0.3 to 1.0    |             |
|                                             | (SRP, SRN)                                       | –1.0 to 1.0    |             |
|                                             | (VC1 to VC2, VC2 to VC3, VC3 to VC4, VC4 to VC5) | –0.3 to 8.5    |             |
|                                             | (WDI, SCLK, SDATA)                               | –0.3 to 8.5    |             |
| Output voltage range                        | (DSG, CHG)                                       | –0.3 to BAT    |             |
|                                             | (ZVCHG)                                          | –0.3 to 34     |             |
|                                             | (GPOD)                                           | –0.3 to 34     |             |
|                                             | (TOUT, SDATA, CELL, XALERT, XRST, LEDOUT)        | –0.3 to 7      |             |
|                                             | (CELL+)                                          | –0.3 to 7      |             |
| Current for cell balancing                  |                                                  | 10             | mA          |
| Storage temperature range, T <sub>stg</sub> |                                                  | –65 to 150     | °C          |

- (1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are with respect to ground of this device except VC<sub>n</sub>–VC<sub>(n+1)</sub>, where n=1, 2, 3, 4 cell voltage.

## RECOMMENDED OPERATING CONDITIONS

|                            |                              |                                | MIN     | NOM    | MAX     | UNIT |
|----------------------------|------------------------------|--------------------------------|---------|--------|---------|------|
| Supply voltage ( VCC, BAT) |                              |                                | 4.5     |        | 25      | V    |
| V <sub>I(STARTUP)</sub>    | Start up voltage (VCC, BAT)  |                                | 5.5     |        |         | V    |
| V <sub>I</sub>             | Input voltage range          | VC1, VC2, VC3, VC4             | 0       |        | VDD     | V    |
|                            |                              | VC5                            | 0       |        | 0.5     |      |
|                            |                              | SRP, SRN                       | −0.5    |        | 0.5     |      |
|                            |                              | VCn – VC(n+1), (n=1, 2, 3, 4 ) | 0       |        | 5.0     |      |
|                            |                              | PACK, PMS                      |         |        | 25      |      |
| V <sub>IH</sub>            | Logic level input voltage    | SCLK, SDATA, WDI               | 0.8×REG |        | REG     | V    |
| V <sub>IL</sub>            |                              |                                | 0       |        | 0.2×REG |      |
| V <sub>O</sub>             | Output voltage               | GPOD                           |         |        | 25      | V    |
| V <sub>O</sub>             | Output voltage range         | XALERT, SDATA, XRST            |         |        | REG     | V    |
|                            |                              | CELL+, CELL−                   |         | 0.975  |         |      |
|                            | External 2.5-V REG capacitor | C <sub>REG</sub>               | 1.0     |        |         | μF   |
|                            | External LEDOUT capacitor    | C <sub>LED</sub>               | 2.2     |        |         | μF   |
|                            | Extend CELL output capacitor | C <sub>CELL</sub>              |         | 0.1    |         | μF   |
|                            | IOL                          | GPOD                           |         |        | 1       | mA   |
|                            | RPACK                        |                                |         | 1      |         | kΩ   |
|                            | Input frequency              | WDI                            |         | 32.768 |         | kHz  |
|                            | WDI high time                |                                | 2       |        |         | μs   |
| T <sub>A</sub>             | Operating temperature        |                                | −25     |        | 85      | °C   |
|                            | Functional temperature       |                                | −40     |        | 110     | °C   |

## ELECTRICAL CHARACTERISTICS

| SUPPLY CURRENT, T <sub>A</sub> = 25°C, C <sub>REG</sub> = 1 μF, C <sub>L</sub> = 2.2 μF, VCC or BAT = 14 V (unless otherwise noted)                          |                                                         |                                                                                                                                                       |                                 |       |     |      |      |
|--------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------|-------|-----|------|------|
| PARAMETER                                                                                                                                                    |                                                         | TEST CONDITIONS                                                                                                                                       |                                 | MIN   | TYP | MAX  | UNIT |
| I <sub>CC1</sub>                                                                                                                                             | Supply Current 1                                        | No load at REG, LEDOUT, TOUT, XALERT, SCLK, SDATA, ZVCHG= off, WDI = 32 kHz<br>VMEN = on, VC5 = VC4 = VC3 = VC2 = VC1 = 0 V<br>select VC5 = VC4 = 0 V | T <sub>A</sub> = 25°C           | 140   | 190 | μA   |      |
|                                                                                                                                                              |                                                         |                                                                                                                                                       | T <sub>A</sub> = −40°C to 110°C |       | 220 | μA   |      |
| I <sub>CC2</sub>                                                                                                                                             | Supply Current 2                                        | No load at REG, LEDOUT TOUT, XALERT, SCLK, SDATA. ZVCHG = off, WDI = 32 kHz, VMEN = off                                                               | T <sub>A</sub> = −40°C to 110°C | 105   | 185 | μA   |      |
| I <sub>(SLEEP)</sub>                                                                                                                                         | Sleep current                                           | CHG, DSG and ZVCHG = off, REG = on, VMEN = off, WDI no clock, SLEEP = 1                                                                               | T <sub>A</sub> = −40°C to 110°C | 30    | 50  | μA   |      |
| I <sub>(SHUTDOWN)</sub>                                                                                                                                      | Shutdown mode                                           | CHG, DSG and ZVCHG = off, REG = off, VMEN = off, WDI no clock, VPACK = 0 V, VC1 = VC2 = VC3 = VC4 = 3.5 V                                             | T <sub>A</sub> = −40°C to 110°C | 0.1   | 1   | μA   |      |
| 2.5 V LDO, T <sub>A</sub> = 25°C, C <sub>REG</sub> = 1 μF, C <sub>L</sub> = 2.2 μF, VCC or BAT = 14 V, I <sub>OUT33</sub> = 0 mA (unless otherwise noted)    |                                                         |                                                                                                                                                       |                                 |       |     |      |      |
| V <sub>(REG)</sub>                                                                                                                                           | Regulator output voltage                                | 4.5 V < VCC or BAT ≤ 25 V, I <sub>OUT25</sub> ≤ 16 mA                                                                                                 | T <sub>A</sub> = −40°C to 110°C | 2.41  | 2.5 | 2.59 | V    |
| ΔV <sub>(EGTEMP)</sub>                                                                                                                                       | Regulator output change with temperature                | VCC or BAT = 14 V, I <sub>OUT25</sub> = 2 mA                                                                                                          | T <sub>A</sub> = −40°C to 110°C | ±0.2% |     |      |      |
| ΔV <sub>(REGLINE)</sub>                                                                                                                                      | Line regulation                                         | 5.4 V ≤ VCC or BAT ≤ 25 V, I <sub>OUT25</sub> = 2 mA                                                                                                  | T <sub>A</sub> = 25°C           | 3     | 10  | mV   |      |
| ΔV <sub>(REGLOAD)</sub>                                                                                                                                      | Load regulation                                         | VCC or BAT = 14 V, 0.2 mA ≤ I <sub>OUT25</sub> ≤ 2 mA                                                                                                 | T <sub>A</sub> = 25°C           | 7     | 15  | mV   |      |
|                                                                                                                                                              |                                                         | VCC or BAT = 14 V, 0.2 mA ≤ I <sub>OUT25</sub> ≤ 16 mA                                                                                                | T <sub>A</sub> = 25°C           | 15    | 50  | mV   |      |
| I <sub>(REGMAX)</sub>                                                                                                                                        | Current limit                                           | VCC or BAT = 14 V, REG = 2 V                                                                                                                          | T <sub>A</sub> = 25°C           | 16    | 75  | mA   |      |
|                                                                                                                                                              |                                                         | VCC or BAT = 14 V, REG = 0 V                                                                                                                          | T <sub>A</sub> = 25°C           | 5     | 45  |      |      |
| 3.3 V LED, T <sub>A</sub> = 25°C, C <sub>REG</sub> = 1.0 μF , C <sub>L</sub> = 2.2 μF, VCC or BAT = 14 V, I <sub>OUT25</sub> = 0 mA (unless otherwise noted) |                                                         |                                                                                                                                                       |                                 |       |     |      |      |
| V <sub>O(LED)</sub>                                                                                                                                          | Regulator output voltage                                | 4.5 V < VCC or BAT ≤ 25 V, I <sub>OUT33</sub> ≤ 10 mA                                                                                                 | T <sub>A</sub> = −40°C to 110°C | 3     | 3.3 | 3.6  | V    |
|                                                                                                                                                              |                                                         | 6.5 V < VCC or BAT ≤ 25 V, I <sub>OUT33</sub> ≤ 25 mA                                                                                                 |                                 | 3     | 3.3 | 3.6  |      |
| ΔV <sub>(LEDEMP)</sub>                                                                                                                                       | Regulator output change with temperature                | VCC or BAT = 14 V, I <sub>OUT33</sub> = 2 mA                                                                                                          | T <sub>A</sub> = −40°C to 110°C | ±0.2% |     |      |      |
| ΔV <sub>(LEDLINE)</sub>                                                                                                                                      | Line regulation                                         | 5.4 V ≤ VCC or BAT ≤ 25 V, I <sub>OUT33</sub> = 2 mA                                                                                                  | T <sub>A</sub> = 25°C           | 3     | 10  | mV   |      |
| ΔV <sub>(LEDLOAD)</sub>                                                                                                                                      | Load regulation                                         | VCC or BAT = 14 V, 0.2 mA ≤ I <sub>OUT33</sub> ≤ 2 mA                                                                                                 | T <sub>A</sub> = 25°C           | 7     | 15  | mV   |      |
|                                                                                                                                                              |                                                         | VCC or BAT = 14 V, 0.2 mA ≤ I <sub>OUT33</sub> ≤ 25 mA                                                                                                |                                 | 40    | 100 |      |      |
| I <sub>(LEDMAX)</sub>                                                                                                                                        | Current limit                                           | VCC or BAT = 14 V, REG = 3 V                                                                                                                          | T <sub>A</sub> = 25°C           | 25    | 125 | mA   |      |
|                                                                                                                                                              |                                                         | VCC or BAT = 14 V, REG = 0 V                                                                                                                          |                                 | 12    | 50  |      |      |
| THERMISTOR DRIVE, T <sub>A</sub> = 25°C, C <sub>REG</sub> = 1 μF, C <sub>L</sub> = 2.2 μF, VCC or BAT = 14 V (unless otherwise noted)                        |                                                         |                                                                                                                                                       |                                 |       |     |      |      |
| VTOUT                                                                                                                                                        |                                                         | I <sub>TOUT</sub> = 0 mA                                                                                                                              |                                 | 2.4   | 2.6 | V    |      |
| R <sub>DS(ON)</sub>                                                                                                                                          | TOUT Pass-element series resistance                     | I <sub>TOUT</sub> = −1 mA at TOUT pin, R <sub>DS(ON)</sub> = [V <sub>REG</sub> − V <sub>OUT</sub> (TOUT)] / 1 mA                                      | T <sub>A</sub> = −40°C to 110°C | 50    | 100 | Ω    |      |
| SHUTDOWN WAKE, T <sub>A</sub> = 25°C, C <sub>REG</sub> = 1 μF, C <sub>L</sub> = 2.2 μF, VCC or BAT = 14 V (unless otherwise noted)                           |                                                         |                                                                                                                                                       |                                 |       |     |      |      |
| V <sub>STARTUP</sub>                                                                                                                                         | PACK Exit shutdown threshold                            | VCC or BAT = 14 V, PACK = 1.4 V                                                                                                                       |                                 |       | 1   | μA   |      |
| POR, T <sub>A</sub> = 25°C, C <sub>REG</sub> = 1 μF, C <sub>L</sub> = 2.2 μF, VCC or BAT = 14 V (unless otherwise noted)                                     |                                                         |                                                                                                                                                       |                                 |       |     |      |      |
| V <sub>POR</sub>                                                                                                                                             | VREGTH−                                                 |                                                                                                                                                       |                                 | −3%   | 1.8 | 3%   | V    |
|                                                                                                                                                              | Hysteresis (V <sub>reath+</sub> − V <sub>reath−</sub> ) |                                                                                                                                                       |                                 | 50    | 150 | 250  | mV   |

## ELECTRICAL CHARACTERISTICS (Continued)

| CELL VOLTAGE MONITOR, $T_A = 25^\circ\text{C}$ , $C_{REG} = 1\ \mu\text{F}$ , $C_L = 2.2\ \mu\text{F}$ , $V_{CC}$ or $BAT = 14\ \text{V}$ (unless otherwise noted) |                                  |                                                                                                             |       |         |       |               |
|--------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------------------|-------------------------------------------------------------------------------------------------------------|-------|---------|-------|---------------|
| PARAMETER                                                                                                                                                          |                                  | TEST CONDITIONS                                                                                             | MIN   | TYP     | MAX   | UNIT          |
| $V_{(\text{CELLOUT})}$                                                                                                                                             | CELL output                      | $V_{Cn} - V_{Cn+1} = 0\ \text{V}$ , $8\ \text{V} \leq V_{DD} \leq 25\ \text{V}$                             | 0.950 | 0.975   | 1     | V             |
|                                                                                                                                                                    |                                  | $V_{Cn} - V_{Cn+1} = 4.5\ \text{V}$ , $8\ \text{V} \leq V_{DD} \leq 25\ \text{V}$                           | 0.275 | 0.3     | 0.325 |               |
| REF                                                                                                                                                                |                                  | Mode <sup>(1)</sup> , $8\ \text{V} \leq V_{DD} \leq 25\ \text{V}$                                           | –1%   | 0.975   | 1%    | V             |
| PACK                                                                                                                                                               |                                  | Mode<br>[Register Address = 0x03, b1(PACK) = 1, b0(VMEN) = 1]                                               | –2%   | PACK/18 | 2%    | V             |
| BAT                                                                                                                                                                |                                  | Mode<br>[Register Address = 0x03, b6(BAT) = 1, b0(VMEN) = 1]                                                | –2%   | BAT/18  | 2%    | V             |
| CMRR                                                                                                                                                               | Common mode rejection            | CELL max to CELL min                                                                                        | 40    |         |       | dB            |
| $V_{(\text{CELLSLEW})}$                                                                                                                                            | CELL output rise                 | Min to Max 10% to 90%                                                                                       | 9     |         |       | ms            |
| K                                                                                                                                                                  | CELL scale factor                | $K = \{\text{CELL output (VC5 = 0 V, VC4 = 4.5 V)}$<br>$\text{–CELL output (VC5 = VC4 = 0 V)}\} / 4.5$      | 0.147 | 0.150   | 0.153 |               |
|                                                                                                                                                                    |                                  | $K = \{\text{CELL output (VC2 = 13.5 V, VC1 = 18 V)}$<br>$\text{–CELL output (VC2 = VC1 = 13.5 V)}\} / 4.5$ | 0.147 | 0.150   | 0.153 |               |
| $I_{(\text{VCELLOUT})}$                                                                                                                                            | Drive current                    | $V_{Cn} - V_{Cn+1} = 0\ \text{V}$ , $V_{\text{cell}} = 0\ \text{V}$ , $T_A = -40^\circ$ to $110^\circ$      | 12    | 18      |       | $\mu\text{A}$ |
| $V_{\text{ICR}}$                                                                                                                                                   | CELL output offset error         | CELL output (VC2 = 18 V, VC1 = 18 V)<br>–CELL output (VC2 = VC1 = 0 V)                                      |       | –1      |       | mV            |
| $R_{(\text{BAL})}$                                                                                                                                                 | Cell balance internal resistance | $R_{\text{DS(ON)}}$ for internal FET switch at $V_{\text{DS}} = 2\ \text{V}$                                | –50%  | 400     | 50%   | $\Omega$      |

(1) Register Address = 0x04, b2(CAL0) = b3(CAL1) = 1, Register Address = 0x03, b0(VMEN) = 1

| CURRENT PROTECTION DETECTION, $T_A = 25^\circ\text{C}$ , $C_{REG} = 1\ \mu\text{F}$ , $C_L = 2.2\ \mu\text{F}$ , $V_{CC}$ or $BAT = 14\ \text{V}$ (unless otherwise noted) |                                                               |                                                       |      |       |        |      |
|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------------------------------------|-------------------------------------------------------|------|-------|--------|------|
| PARAMETER                                                                                                                                                                  |                                                               | TEST CONDITIONS                                       | MIN  | TYP   | MAX    | UNIT |
| $V_{(\text{OLT})}$                                                                                                                                                         | OL detection threshold voltage range, typical <sup>(1)</sup>  | RSNS = 0                                              | –50  |       | –205   | mV   |
|                                                                                                                                                                            |                                                               | RSNS = 1                                              | –25  |       | –102.5 |      |
| $\Delta V_{(\text{OLT})}$                                                                                                                                                  | OL detection threshold voltage program step                   | RSNS = 0                                              |      | –5    |        | mV   |
|                                                                                                                                                                            |                                                               | RSNS = 1                                              |      | –2.5  |        |      |
| $V_{(\text{SCCT})}$                                                                                                                                                        | SCC detection threshold voltage range, typical <sup>(2)</sup> | RSNS = 0                                              | 100  |       | 475    | mV   |
|                                                                                                                                                                            |                                                               | RSNS = 1                                              | 50   |       | 237.5  |      |
| $\Delta V_{(\text{SCCT})}$                                                                                                                                                 | SCC detection threshold voltage program step                  | RSNS = 0                                              |      | 25    |        | mV   |
|                                                                                                                                                                            |                                                               | RSNS = 1                                              |      | 12.5  |        |      |
| $V_{(\text{SCDT})}$                                                                                                                                                        | SCD detection threshold voltage range, typical <sup>(3)</sup> | RSNS = 0                                              | –100 |       | –475   | mV   |
|                                                                                                                                                                            |                                                               | RSNS = 1                                              | –50  |       | –237.5 |      |
| $\Delta V_{(\text{SCDT})}$                                                                                                                                                 | SCD detection threshold voltage program step                  | RSNS = 0                                              |      | –25   |        | mV   |
|                                                                                                                                                                            |                                                               | RSNS = 1                                              |      | –12.5 |        |      |
| $V_{\text{OL(acr)}}$                                                                                                                                                       | OL detection threshold voltage accuracy <sup>(1)</sup>        | $V_{\text{OL}} = -25\ \text{mV (typ)}$                | –15  | –25   | –35    | mV   |
|                                                                                                                                                                            |                                                               | $V_{\text{OL}} = -100\ \text{mV (typ) (RSNS = 0,1)}$  | –90  | –100  | –110   |      |
|                                                                                                                                                                            |                                                               | $V_{\text{OL}} = -205\ \text{mV (typ)}$               | –185 | –205  | –225   |      |
| $V_{(\text{SCC\_acr})}$                                                                                                                                                    | SCC detection threshold voltage accuracy <sup>(2)</sup>       | $V_{\text{SCC}} = 50\ \text{mV (typ)}$                | 30   | 50    | 70     | mV   |
|                                                                                                                                                                            |                                                               | $V_{\text{SCC}} = 200\ \text{mV (typ) (RSNS = 0,1)}$  | 180  | 200   | 220    |      |
|                                                                                                                                                                            |                                                               | $V_{\text{SCC}} = 475\ \text{mV (typ)}$               | 428  | 475   | 523    |      |
| $V_{(\text{SCD\_acr})}$                                                                                                                                                    | SCD detection threshold voltage accuracy <sup>(3)</sup>       | $V_{\text{SCD}} = -50\ \text{mV (typ)}$               | –30  | –50   | –70    | mV   |
|                                                                                                                                                                            |                                                               | $V_{\text{SCD}} = -200\ \text{mV (typ) (RSNS = 0,1)}$ | –180 | –200  | –220   |      |
|                                                                                                                                                                            |                                                               | $V_{\text{SCD}} = -475\ \text{mV (typ)}$              | –426 | –475  | –523   |      |

(1) See OLV register for setting detection threshold

(2) See SCC register for setting detection threshold

(3) See SCD register for setting detection threshold

## ELECTRICAL CHARACTERISTICS (Continued)

| FET DRIVE CIRCUIT, T <sub>A</sub> = 25°C, C <sub>REG</sub> = 1 μF, C <sub>L</sub> = 2.2 μF, VCC or BAT = 14 V (unless otherwise noted) |                                                |                                                                                      |                                                                    |     |     |      |      |
|----------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------|--------------------------------------------------------------------------------------|--------------------------------------------------------------------|-----|-----|------|------|
| PARAMETER                                                                                                                              |                                                | TEST CONDITIONS                                                                      |                                                                    | MIN | TYP | MAX  | UNIT |
| V <sub>O(FETON)</sub>                                                                                                                  | Output voltage, charge, and discharge FETs on  | V <sub>O(FETOND)</sub> = V <sub>(DSG)</sub> – V <sub>pack</sub><br>VGS connect 10 MΩ | T <sub>A</sub> = 25°C                                              | 7.5 | 12  | 15.5 | V    |
|                                                                                                                                        |                                                |                                                                                      | T <sub>A</sub> = –40°C to 110°C                                    | 8   | 12  | 16   |      |
|                                                                                                                                        |                                                | V <sub>O(FETONC)</sub> = V <sub>(CHG)</sub> – V <sub>BAT</sub><br>VGS connect 10 MΩ  | T <sub>A</sub> = 25°C                                              | 7.5 | 12  | 15.5 | V    |
|                                                                                                                                        |                                                |                                                                                      | T <sub>A</sub> = –40°C to 110°C                                    | 8   | 12  | 16   |      |
| V <sub>(ZCHG)</sub>                                                                                                                    | ZVCHG clamp voltage                            | BAT = 4.5 V                                                                          |                                                                    | 3.3 | 3.5 | 3.7  | V    |
| V <sub>O(FETOF)</sub>                                                                                                                  | Output voltage, charge, and discharge FETs off | VFETOND = VD SG – V <sub>pack</sub>                                                  |                                                                    |     |     | 0.2  | V    |
|                                                                                                                                        |                                                | VFETONC = VCHG – V <sub>BAT</sub>                                                    |                                                                    |     |     | 0.2  |      |
| t <sub>r</sub>                                                                                                                         | Rise time                                      | C <sub>L</sub> = 4700 pF                                                             | V <sub>(CHG)</sub> : V <sub>pack</sub> ≥ V <sub>pack</sub> + 4 V   |     | 400 | 1000 | μs   |
|                                                                                                                                        |                                                |                                                                                      | V <sub>(DSG)</sub> : V <sub>BAT</sub> ≥ V <sub>BAT</sub> + 4 V     |     | 400 | 1000 |      |
| t <sub>f</sub>                                                                                                                         | Fall time                                      | C <sub>L</sub> = 4700 pF                                                             | V <sub>(CHG)</sub> : V <sub>pack</sub> + VCHG (FETON) ≥ pack + 1 V |     | 40  | 200  | μs   |
|                                                                                                                                        |                                                |                                                                                      | V <sub>(DSG)</sub> : VC1 + VD SG (FETON) ≥ VC1 + 1 V               |     | 40  | 200  |      |
| LOGIC, T <sub>A</sub> = 25°C, C <sub>REG</sub> = 1 μF, C <sub>L</sub> = 2.2 μF, VCC or BAT = 14 V (unless otherwise noted)             |                                                |                                                                                      |                                                                    |     |     |      |      |
| R <sub>(PUP)</sub>                                                                                                                     | Internal pullup resistance                     | XALERT                                                                               | T <sub>A</sub> = –40°C to 110°C                                    | 60  | 100 | 200  | kΩ   |
|                                                                                                                                        |                                                | SDATA, SCLK                                                                          |                                                                    | 6   | 10  | 20   |      |
|                                                                                                                                        |                                                | XRST                                                                                 |                                                                    | 1   | 3   | 6    |      |
| V <sub>OL</sub>                                                                                                                        | Low Logic level output voltage                 | XALERT                                                                               | T <sub>A</sub> = –40°C to 110°C                                    |     |     | 0.2  | V    |
|                                                                                                                                        |                                                | SDATA, I <sub>OUT</sub> = 200 μA                                                     |                                                                    |     |     | 0.4  |      |
|                                                                                                                                        |                                                | GPOD, I <sub>OUT</sub> = 50 μA                                                       |                                                                    |     |     | 0.6  |      |
|                                                                                                                                        |                                                | VCC or BAT = 7 V, VREG = 1.5 V, XRST, I <sub>OUT</sub> = 200 μA                      |                                                                    |     |     | 0.4  |      |
| V <sub>IH</sub>                                                                                                                        | SCLK (hysteresis input)                        | Hysteresis                                                                           |                                                                    |     | 450 |      | mV   |

## AC ELECTRICAL CHARACTERISTICS

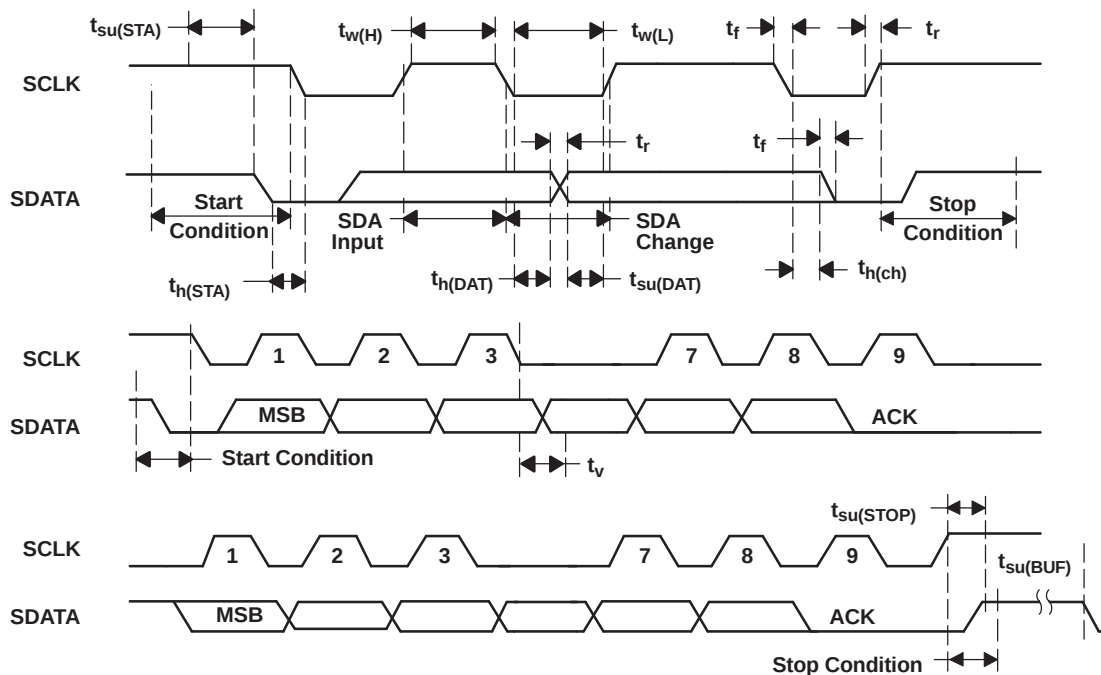
 $T_A = 25^\circ\text{C}$ ,  $C_{REG} = 1\ \mu\text{F}$ ,  $C_L = 2.2\ \mu\text{F}$ ,  $V_{CC}$  or  $BAT = 14\ \text{V}$  (unless otherwise noted)

| PARAMETER                                    | TEST CONDITIONS | MIN | TYP | MAX  | UNIT          |
|----------------------------------------------|-----------------|-----|-----|------|---------------|
| $t_{\text{WDTINT}}$ WDT start up detect time |                 | 250 | 500 | 1000 | ms            |
| $t_{\text{WDWT}}$ WDT detect time            |                 | 50  | 100 | 150  | $\mu\text{s}$ |
| $t_{\text{RST}}$ XRST Active high time       |                 | 100 | 250 | 560  | $\mu\text{s}$ |

## AC TIMING REQUIREMENTS (I<sup>2</sup>C compatible serial interface)

T<sub>A</sub> = 25°C, C<sub>REG</sub> = 1 µF, VCC or BAT = 14 V (unless otherwise noted)

| PARAMETER             |                                                                      | MIN | MAX  | UNIT |
|-----------------------|----------------------------------------------------------------------|-----|------|------|
| t <sub>r</sub>        | SCLK, SDATA rise time                                                |     | 1000 | ns   |
| t <sub>f</sub>        | SCLK, SDATA fall time                                                |     | 300  | ns   |
| t <sub>w(H)</sub>     | SCLK pulse width high                                                | 4   |      | µs   |
| t <sub>w(L)</sub>     | SCLK pulse width low                                                 | 4.7 |      | µs   |
| t <sub>su(STA)</sub>  | Setup time for start condition                                       | 4.7 |      | µs   |
| t <sub>h(STA)</sub>   | Start condition hold time after which first clock pulse is generated | 4   |      | µs   |
| t <sub>su(DAT)</sub>  | Data setup time                                                      | 250 |      | ns   |
| t <sub>h(DAT)</sub>   | Data hold time                                                       | 0   |      | µs   |
| t <sub>su(STOP)</sub> | Setup time for Stop condition                                        | 4   |      | µs   |
| t <sub>su(BUF)</sub>  | Time the bus must be free before new transmission can start          | 4.7 |      | µs   |
| t <sub>v</sub>        | Clock low to data out valid                                          |     | 900  | ns   |
| t <sub>h(CH)</sub>    | Data out hold time after clock low                                   | 10  |      | ns   |
| f <sub>SCL</sub>      | Clock frequency                                                      | 0   | 100  | kHz  |



## FUNCTIONAL DESCRIPTION

### LOW DROP OUTPUT REGULATOR (LEDOUT)

The inputs for this regulator can be derived from the VCC or BAT terminals. The output is a fixed voltage of typically 3.3 V with the minimum output capacitance for stable operation of 2.2  $\mu$ F and is also internally current limited. This output is used for LED drive, power supply source for REG (2.5 V) and bq29330 internal circuit. During normal operation, the regulator limits output current to typically 50 mA. Until the internal regulator circuit is correctly powered, the DSG and CHG FET drives are low (FETs = OFF).

### LOW DROP OUTPUT REGULATOR (REG)

The inputs for this regulator can be derived from the LED (3.3 V). The output is typically 2.5 V with the minimum output capacitance for stable operation of 1  $\mu$ F and is also internally current limited. During normal operation, the regulator limits output current to typically 50 mA.

### INITIALIZATION

From a shutdown situation, the bq29330 requires a voltage greater than start-up voltage ( $V_{STARTUP}$ ) applied to the PACK pin to enable its integrated regulator and provide the regulators power source. Once the REG output is stable, the power source of the regulator is switched to VCC.

After the regulator has started, it then continues to operate through the VCC input. If the VCC input is below the minimum operating range, then the bq29330 will not operate if the supply to the PACK input is removed.

If the voltage at VLED falls below about 2.3 V, the internal circuit turns off the FETs and disables all controllable functions including the REG, LEDOUT, and TOUT outputs.

The initial state of the CHG and DSG FET drive is low (OFF) and the ZVCHG FET drive is low (ON).

### OVERLOAD DETECTION

The overload detection is used to detect abnormal currents in the discharge direction. This feature is used to protect the pass FETs, cells, and any other inline components from excessive discharge current conditions. The detection circuit also incorporates a blanking delay before driving the control for the pass FETs to the OFF state. The overload sense voltage is set in the OLV register, and delay time is set in the OLD register. The thresholds can be individually programmed from 50 mV to 205 mV in 5-mV steps with the default being 50 mV.

If the RSNS bit in the FUNCTION\_CTL register is set to 1, then the voltage threshold, programmable step size, and hysteresis is divided by 2.

### SHORT CIRCUIT IN CHARGE AND SHORT CIRCUIT IN DISCHARGE DETECTION

The short current circuit in charge and short circuit in discharge detections are used to detect severe abnormal current in the charge and discharge directions, respectively. This safety feature is used to protect the pass FETs, cells, and any other inline components from excessive current conditions. The detection circuit also incorporates a blanking delay before driving the control for the pass FETs to the OFF state. The short circuit in charge threshold and delay time are set in the SCC register. The short circuit in discharge threshold and delay time are set in the SCD register. The short-circuit thresholds can be programmed from 100 mV to 475 mV in 25-mV steps.

If the RSNS bit in the FUNCTION\_CTL register is set to 1, then the voltage threshold, programmable step size, and hysteresis is divided by 2.

### OVERLOAD, SHORT CIRCUIT IN CHARGE AND SHORT CIRCUIT IN DISCHARGE DELAY

The overload delay (default = 1 ms) allows the system to momentarily accept a high current condition without disconnecting the supply to the load. The delay time can be increased via the OLD register which can be programmed for a range of 1 ms to 31 ms with 2-ms steps.

The short circuit in charge and short circuit in discharge delays (default = 0  $\mu$ s) are programmable in the SCC and SCD registers, respectively. These registers can be programmed from 0  $\mu$ s to 915  $\mu$ s with 61- $\mu$ s steps.

## OVERLOAD, SHORT CIRCUIT IN CHARGE AND SHORT CIRCUIT IN DISCHARGE RESPONSE

When an overload, short circuit in charge, or short circuit in discharge fault is detected, the FETs are turned off. The STATUS (b0...b3) register reports the details of overload, short circuit in charge or short-circuit discharge. The respective STATUS (b0...b3) bits are set to 1 and the XALERT output is triggered. This condition is latched until the STATE\_CONTROL (b7) is set and then reset. If a FET is turned on after resetting STATE\_CONTROL (b0) and the error condition is still present on the system, then the device again enters the protection response state.

## 2-, 3-, or 4-CELL CONFIGURATION

In a 2-cell configuration, VC1 and VC2 are shorted to VC3. In a 3-cell configuration, VC1 is shorted to VC2.

## CELL VOLTAGE

The cell voltage is translated to allow a system host to measure individual series elements of the battery. The series element voltage is translated to a GND-based voltage equal to  $0.15 \pm 0.003$  of the series element voltage. This provides a range from 0 to 4.5 V. The translation output is presented between CELL+ and CELL– pins of the bq29330 and is inversely proportional to the input using the following equation.

$$\text{Where, } V_{(\text{CELLOUT})} = -K \times V_{(\text{CELLIN})} + 0.975 \text{ (V)}$$

Programming CELL\_SEL (b1, b0) selects the individual series element. The CELL\_SEL (b3, b2) selects the voltage monitor mode, cell monitor, offset, etc.

## CALIBRATION OF CELL VOLTAGE MONITOR AMPLIFIER GAIN

The cell voltage monitor amplifier has an offset, and to increase accuracy, this can be calibrated.

The following procedure shows how to measure and calculate the offset as an example.

### Step 1

Set CAL1=1, CAL0=1, VMEN=1.

VREF is trimmed to 0.975 V within  $\pm 1\%$ ; measuring VREF eliminates its error.

Measure internal reference voltage VREF from VCELL directly.

$$V_{\text{REF}} = \text{measured reference voltage}$$

### Step 2

Set CAL1=0, CAL0=1, CELL1=0, CELL0=0, VMEN=1.

The output voltage includes the offset and represented by:

$$V_{\text{OUT(4-5)}} = V_{\text{REF}} + (1 + K) \times V_{\text{OS}} \text{ (V)}$$

Where K = CELL Scaling Factor

$V_{\text{OS}}$  = Offset voltage at input of the internal operational amplifier

### Step 3

Set CAL1=1, CAL0=0, CELL1=0, CELL0=0, VMEN=1.

Measure scaled REF voltage through VCELL amplifier.

The output voltage includes the scale factor error and offset and is represented by:

$$V_{(\text{OUTR})} = V_{\text{REF}} + (1 + K) \times V_{\text{OS}} - K \times V_{\text{REF}} \text{ (V)}$$

### Step 4

Calculate  $(V_{\text{OUT(4-5)}} - V_{(\text{OUTR})}) / V_{\text{REF}}$ .

The result is the actual scaling factor,  $K_{\text{ACT}}$  and is represented by:

$$K_{\text{ACT}} = (V_{\text{OUT(4-5)}} - V_{(\text{OUTR})}) / V_{\text{REF}} = (V_{\text{REF}} + (1 + K) \times V_{\text{OS}}) - (V_{\text{REF}} + (1 + K) \times V_{\text{OS}} - K \times V_{\text{REF}}) / V_{\text{REF}} = K \times V_{\text{REF}} / V_{\text{REF}} = K$$

### Step 5

Calculate the actual offset value where:

$$V_{OS(ACT)} = (V_{OUTR} - V_{REF}) / (1 + K_{ACT})$$

### Step 6

Calibrated cell voltage is calculated by:

$$VC_n - VC_{(n+1)} = \{ V_{REF} + (1 + K_{ACT}) \times V_{OS(ACT)} - V_{(CELLOUT)} \} / K_{ACT} = \{ V_{OUT(4-5)} - V_{(CELLOUT)} \} / K_{ACT}$$

To seek greater accuracy, it is better to measure  $V_{OS(ACT)}$  for each cell voltage.

Set CAL1=0, CAL0=0, CELL1=0, CELL0=1, VMEN=1.

Set CAL1=0, CAL0=0, CELL1=1, CELL0=0, VMEN=1.

Set CAL1=0, CAL0=0, CELL1=1, CELL0=1, VMEN=1.

Measure  $V_{OUT(3-4)}$ ,  $V_{OUT(2-3)}$ ,  $V_{OUT(1-2)}$ ,

$$VC_4 - VC_5 = \{ V_{OUT(4-5)} - V_{(CELLOUT)} \} / K_{ACT}$$

$$VC_3 - VC_4 = \{ V_{OUT(3-4)} - V_{(CELLOUT)} \} / K_{ACT}$$

$$VC_2 - VC_3 = \{ V_{OUT(2-3)} - V_{(CELLOUT)} \} / K_{ACT}$$

$$VC_1 - VC_2 = \{ V_{OUT(1-2)} - V_{(CELLOUT)} \} / K_{ACT}$$

## BATTERY PACK AND BATTERY STACK MEASUREMENTS

The PACK (battery pack) and VC1 (battery stack) inputs can be translated to the CELL+, CELL– outputs of the bq29330 through control bits in the FUNCTION\_CONTROL register. If PACK is set, then the input at the PACK is divided by 18 and presented at the CELL+, CELL– outputs. If the BAT bit is set, then the input to VC1 is divided by 18 and presented at the CELL+, CELL– outputs. If setting both bits at the same time, VC1 is presented at the CELL+, CELL– outputs.

## CELL BALANCE CONTROL

The cell balance control allows a small bypass path to be controlled for any one series element. The purpose of this bypass path is to reduce the current into any one cell during charging to bring the series elements to the same voltage. Series resistors placed between the input pins and the positive series element nodes control the bypass current value. Individual series element selection is made using bits 4 through 7 of CELL\_SEL register.

Series input resistors between 500  $\Omega$  and 1 k $\Omega$  are recommended for effective cell balancing.

## XALERT (XALERT)

XALERT is driven Low, when WDF, OL, SCC, or SCD OC are detected. To clear XALERT, toggle (from 0, set to 1, then reset to 0) STATE\_CONTROL, LTCLR (bit 7), then read the STATUS register.

## THERMISTOR DRIVE CIRCUIT (TOUT)

The TOUT pin can be enabled to drive a thermistor from REG. The typical thermistor resistance is 10 k $\Omega$  at 25°C. The default state for this is OFF to conserve power. The maximum output impedance is 100  $\Omega$ . TOUT is enabled in FUNCTION\_CONTROL register (bit 3).

## GENERAL PURPOSE OPEN DRAIN DRIVE CIRCUIT (GPOD)

The General Purpose Open Drain output has 1-mA current source drive with a maximum output voltage of 25 V. The OD output is enabled or disabled by OUTPUT\_CONTROL register (bit 4) and has a default state of OFF.

## LATCH CLEAR (LTCLR)

When a protection fault occurs, the state is latched. To clear the fault flag, toggle (from 0, set 1, then reset to 0) the LTCLR bit in the STATE\_CONTROL register (bit 7). The OL, SCC, SCD, and WDF bits are unlatched by this function. The FETs can now be controlled by programming the OUTPUT\_CONTROL register, and the XALERT output can be cleared by reading the STATUS register.

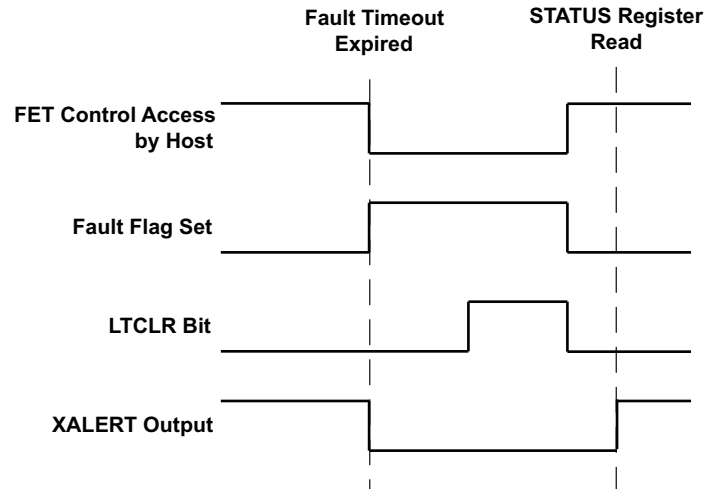


Figure 1. LTCLR and XLAERT Clear Timing

## POR and WATCHDOG RESET (XRST)

The XRST pin is activated by activation of the REG output. This holds the host in reset for the duration of the  $t_{RST}$  period, allowing the VREG to stabilize before the host is released from reset. When the regulator power is down, XRST is active below the regulator's voltage of 1.8 V. Also, when a watchdog fault is detected, the XRST is also activated to ensure a valid reset of the battery management host.

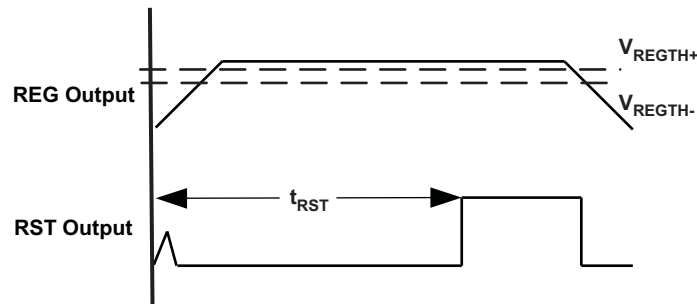


Figure 2. XRST Timing Chart – Power Up and Power Down

## WATCHDOG INPUT (WDI)

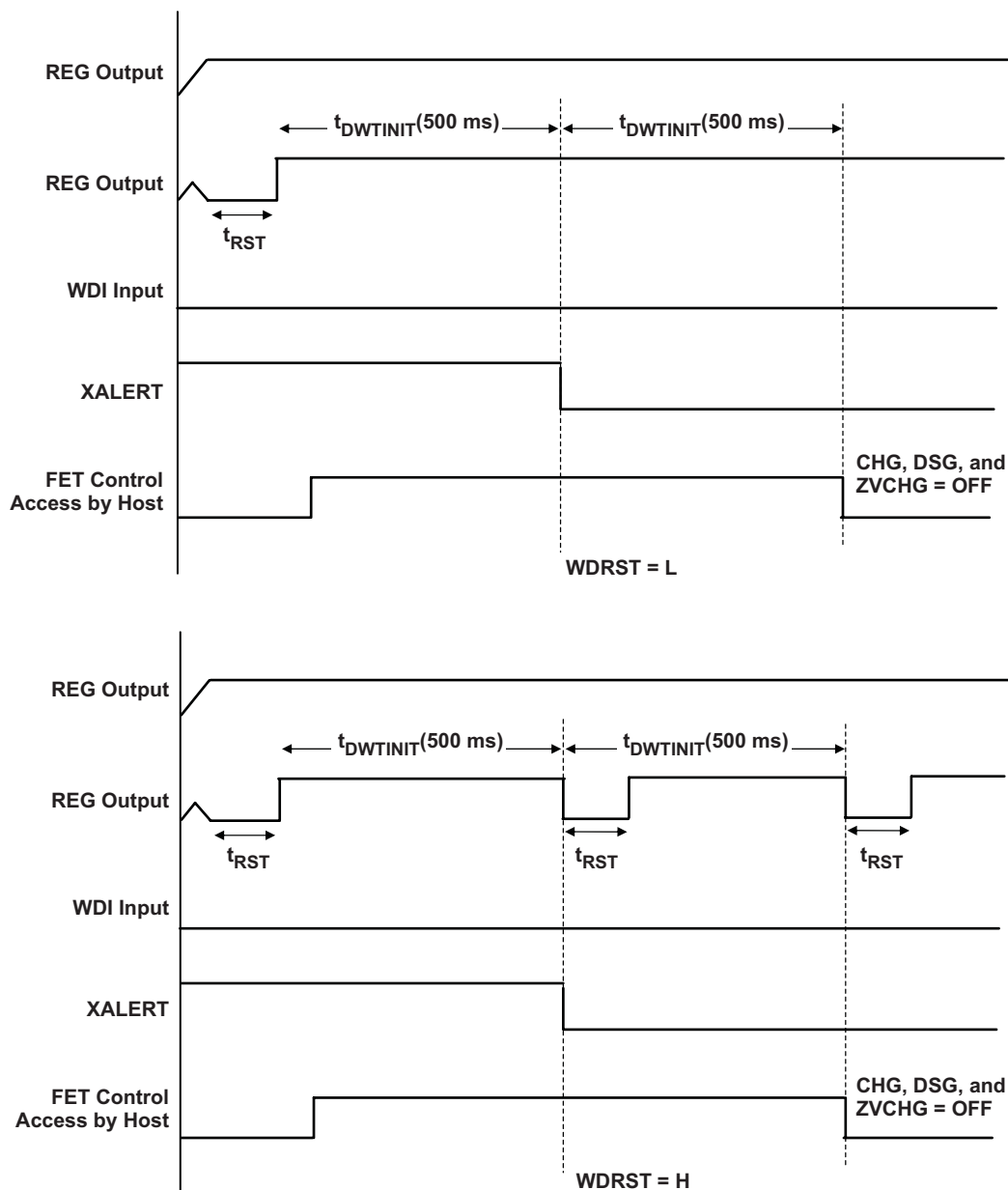
The WDI input is required as a time base for delay timing when determining fault detection and is used as part of the system watchdog.

Initially, the watchdog monitors the host oscillator start-up; if there is no response from the host within  $t_{WDINT}$  of  $t_{RST}$  expiring, then the bq29330 turns CHG, DSG, and ZVCHG FETs off. It then activates the XRST output in an attempt to reset the host.

Once the watchdog has been started during this wake-up period, it monitors the host for an oscillation stop condition which is defined as a period of  $t_{WDWT}$  where no clock input is received. If an oscillator stop condition is identified, then the watchdog turns the CHG, DSG, and ZVCHG FETs off. The bq29330 then activates the XRST output in an attempt to reset the host.

If the host clock oscillation is started after the reset, the bq29330 still has the WDF flag set until it is cleared. See the LTCLR section for further details on clearing the fault flags.

During Sleep mode, the watchdog function is not disabled.



**Figure 3. Watchdog Timing Chart – WDI Fault at Start-up**

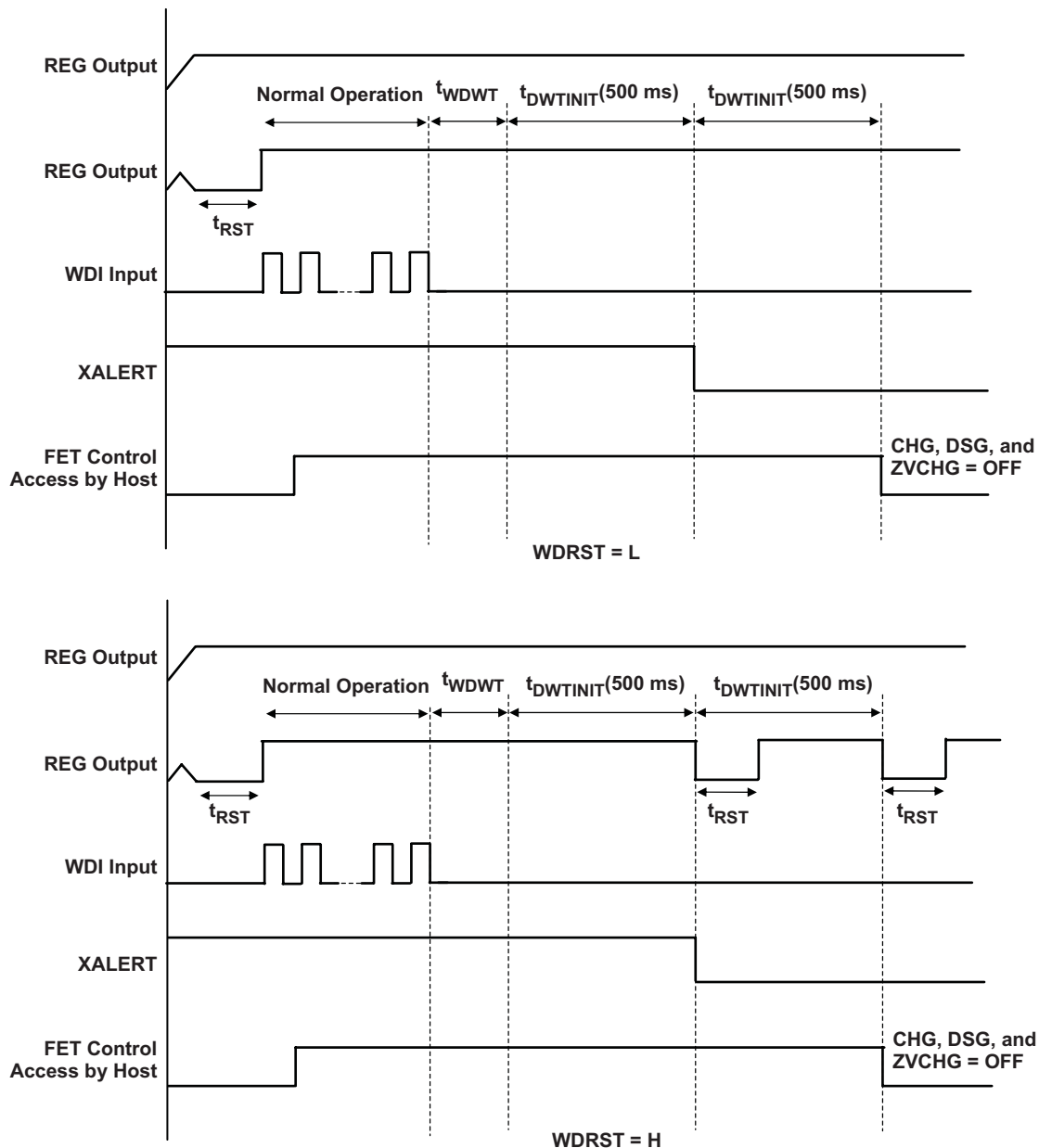


Figure 4. Watchdog Timing Chart – WDI Fault After Startup

## DSG and CHG NCH FET DRIVER CONTROL

The bq29330 drives either the DSG or CHG FET off if an OL, SCC, or SCD safety threshold is breached depending on the current direction. The host can force any FET on or off only if the bq29330 integrated protection control allows.

The default-state of the FET drive is off. A host can control the FET drive by programming OUTPUT\_CONTROL (b2...b0), where b0 is used to control the discharge FET, b1 is used to control the charge FET, and b2 is used to control the ZVCHG FET. These controls are only valid when not in the initialized state. The CHG drive FET can be powered by PACK and the DSG FET can be powered by BAT.

When the bq29330 powers down, the NCH FET drivers power down to GND causing the FETs to turn off.

## PRECHARGE AND 0 V CHARGING

The bq29330 supports both a charger that has a precharge mode and one that does not. The bq29330 also supports charging even when the battery falls to 0 V. In order to charge, the charge FET (CHG) must be turned on to create a current path. When the  $V_{BAT}$  is  $\sim 0$  V, the  $V_{(PACK)}$  is as low as the battery voltage. In this case, the supply voltage for the device is too low to operate.

## POWER MODES

The bq29330 has three power modes, normal, sleep, and ship. The following table outlines the operational functions during these power modes.

**Table 1. Outlines the Operational Functions**

| POWER MODE | TO ENTER POWER MODE                                               | TO EXIT POWER MODE            | MODE DESCRIPTION                                                                                                                                                                                                                                   |
|------------|-------------------------------------------------------------------|-------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Normal     | STATE_CONTROL, SLEEP( b0) = 0 and STATE_CONTROL, SHIP ( b1) = 0   |                               | The battery is in normal operation with protection, power management and battery monitoring functions available and operating.<br><br>The supply current of this mode varies as the host can enable and disable various power management features. |
| Sleep      | STATE_CONTROL, SLEEP( b0) = 1 and STATE_CONTROL, SHIP ( b1) = 0   | STATE_CONTROL, SLEEP( b0) = 0 | CHG, DSG, and ZVCHG OFF, OL, SCC, and SCD function is disabled.<br><br>Cell AMP, GPOD , CELL BAL, and WDF is not disabled                                                                                                                          |
| Ship       | STATE_CONTROL, SHIP ( b1) = 1 and supply at the PACK < $V_{WAKE}$ | Supply voltage to PACK Supply | The bq29330 is completely shut down as in the sleep mode. In addition, the REG output is disabled, I <sup>2</sup> C interface is powered down, and memory is not valid.                                                                            |

## VOLTAGE BASED EXIT FROM SHUTDOWN

If a voltage greater than  $V_{STARTUP}$  is applied to the PACK pin, then the bq29330 exits shutdown and enters normal mode.

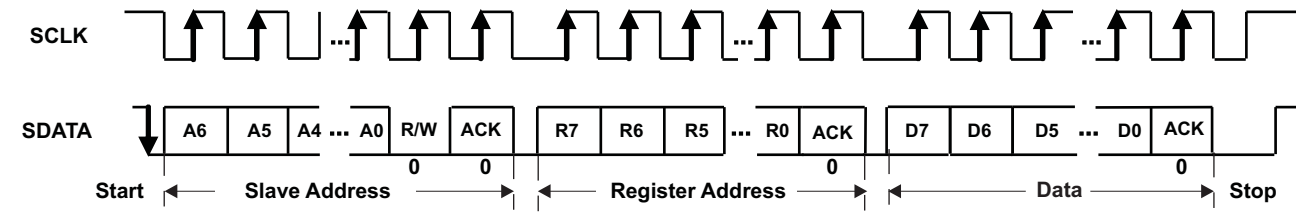
## COMMUNICATIONS

The I<sup>2</sup>C-compatible serial communications provides read and write access to the bq29330 data area. The data is clocked via separate data (SDATA) and clock (SCLK) pins. The bq29330 acts as a slave device and does not generate clock pulses. Communication to the bq29330 can be provided from GPIO pins or an I<sup>2</sup>C supporting port of a host system controller. The slave address for the bq29330 is 7 bits, and the value is 0100 000 (0x20).

|       | (MSB) I2C Address +R/W bit (LSB) |   |   |   |   |   |   |
|-------|----------------------------------|---|---|---|---|---|---|
|       | (MSB) I2C Address (0x20) (LSB)   |   |   |   |   |   |   |
| Write | 0                                | 1 | 0 | 0 | 0 | 0 | 0 |
| Read  |                                  |   |   |   |   |   | 1 |

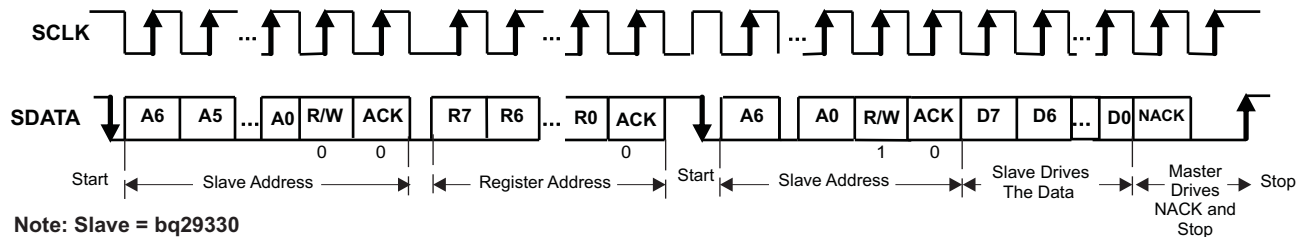
The bq29330 does NOT have the following functions compatible with the I<sup>2</sup>C specification.

- The bq29330 is always regarded as a slave.
- The bq29330 does not support the General Code of the I<sup>2</sup>C specification, and therefore will not return an ACK but may return a NACK.
- The bq29330 does not support the Address Auto Increment, which allows continuous reading and writing.
- The bq29330 will allow data to be written or read from the same location without re-sending the location address.



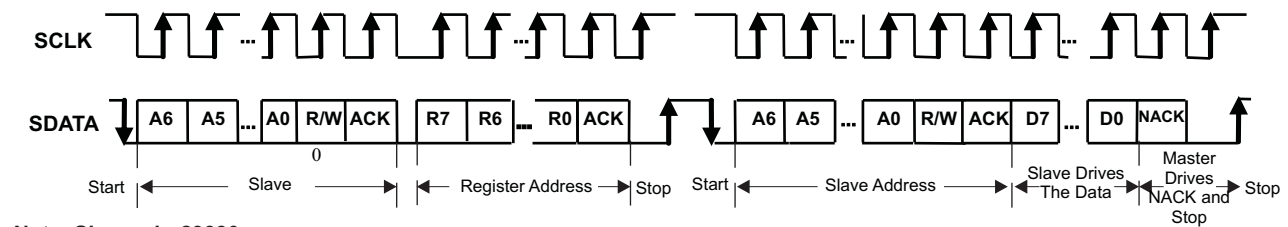
Note: Slave = bq29330

Figure 5. I²C-Bus Write to bq29330



Note: Slave = bq29330

Figure 6. I²C-Bus Read from bq29330: Protocol A



Note: Slave = bq29330

Figure 7. I²C-Bus Read from bq29330: Protocol B

## REGISTER MAP

The bq29330 has nine addressable registers. These registers provide status, control, and configuration information for the battery protection system.

| NAME             | ADDR | TYPE | DESCRIPTION                                                                                 |
|------------------|------|------|---------------------------------------------------------------------------------------------|
| STATUS           | 0x00 | R    | Status register                                                                             |
| OUTPUT_CONTROL   | 0x01 | R/W  | Output pin control from system host and external pin status                                 |
| STATE_CONTROL    | 0x02 | R/W  | State control                                                                               |
| FUNCTION_CONTROL | 0x03 | R/W  | Function control                                                                            |
| CELL_SEL         | 0x04 | R/W  | Battery cell select for cell translation and balance bypass and select mode for calibration |
| OLV              | 0x05 | R/W  | Overload voltage threshold                                                                  |
| OLD              | 0x06 | R/W  | Overload delay time                                                                         |
| SCC              | 0x07 | R/W  | Short circuit in charge current threshold voltage and delay                                 |
| SCD              | 0x08 | R/W  | Short circuit in discharge current threshold voltage and delay                              |

| NAME             | ADDR | TYPE | BIT MAP |       |         |       |       |       |       |       |
|------------------|------|------|---------|-------|---------|-------|-------|-------|-------|-------|
|                  |      |      | B7      | B6    | B5      | B4    | B3    | B2    | B1    | B0    |
| STATUS           | 0x00 | R    | 0       | 0     | 0       | ZV    | WDF   | OL    | SCC   | SCD   |
| OUTPUT_CONTROL   | 0x01 | R/W  | 0       | 0     | PMS_CHG | GPOD  | XZV   | CHG   | DSG   | LTCLR |
| STATE_CONTROL    | 0x02 | R/W  | 0       | 0     | 0       | RSNS  | WDRST | WDDIS | SHIP  | SLEEP |
| FUNCTION_CONTROL | 0x03 | R/W  | 0       | 0     | 0       | 0     | TOUT  | BAT   | PACK  | VMEN  |
| CELL_SEL         | 0x04 | R/W  | CB3     | CB2   | CB1     | CB0   | CAL1  | CAL0  | CELL1 | CELL0 |
| OLV              | 0x05 | R/W  | 0       | 0     | 0       | OLV4  | OLV3  | OLV2  | OLV1  | OLV0  |
| OLD              | 0x06 | R/W  | 0       | 0     | 0       | 0     | OLD3  | OLD2  | OLD1  | OLD0  |
| SCC              | 0x07 | R/W  | SCCD3   | SCCD2 | SCCD1   | SCCD0 | SCCV3 | SCCV2 | SCCV1 | SCCV0 |
| SCD              | 0x08 | R/W  | SCDD3   | SCDD2 | SCDD1   | SCDD0 | SCDV3 | SCDV2 | SCDV1 | SCDV0 |

**STATUS: Status register**

| STATUS REGISTER (0x00) |   |   |    |     |    |     |     |
|------------------------|---|---|----|-----|----|-----|-----|
| 7                      | 6 | 5 | 4  | 3   | 2  | 1   | 0   |
| 0                      | 0 | 0 | ZV | WDF | OL | SCC | SCD |

The STATUS register provides information about the current state of the bq29330.

**STATUS b0 (SCD):** This bit indicates a short circuit in discharge condition.

0 = Voltage below the short circuit in discharge threshold (default).

1 = Voltage greater than or equal to the short circuit in discharge threshold.

**STATUS b1 (SCC):** This bit indicates a short circuit in charge condition in the charge direction.

0 = Voltage below the short circuit in charge threshold (default).

1 = Voltage greater than or equal to the short circuit in charge threshold.

**STATUS b2 (OL):** This bit indicates an overload condition.

0 = Voltage less than or equal to the overload threshold (default).

1 = Voltage greater than overload threshold.

**STATUS b3 (WDF):** This bit indicates a watchdog fault condition has occurred.

0 = 32-kHz oscillation is normal (default).

1 = 32-kHz oscillation stopped or not started, and the watchdog has timed out.

**STATUS b4 (ZV):** This bit indicates ZVCHG output is clamped.

0 = ZVCHG pin is not clamped (default).

1 = ZVCHG pin is clamped.

**STATUS b5, b6, b7:** Reserved

**OUTPUT\_CONTROL : Output control register**

| OUTPUT_CONTROL REGISTER (0x01) |   |         |      |     |     |     |       |
|--------------------------------|---|---------|------|-----|-----|-----|-------|
| 7                              | 6 | 5       | 4    | 3   | 2   | 1   | 0     |
| 0                              | 0 | PMS_CHG | GPOD | XZV | CHG | DSG | LTCLR |

The OUTPUT\_CONTROL register controls the outputs of the bq29330 and can show the state of the external pin corresponding to the control.

**OUTPUT\_CONTROL b0 (LTCLR):** When a fault is latched, this bit releases the fault latch when toggled from 0 to 1 and back to 0 (default =0).

0 = (default)

0->1 ->0 clears the fault latches, allowing STATUS to be cleared on its next read.

OUTPUT\_CONTROL b1 (DSG): This bit controls the external discharge FET.

- 0 = Discharge FET is off and is controlled by the system host (default).
- 1 = Discharge FET is on, and the bq29330 is in normal operating mode.

OUTPUT\_CONTROL b2 (CHG): This bit controls the external charge FET.

- 0 = Charge FET is off, and is controlled by the system host (default).
- 1 = Charge FET is on, and the bq29330 is in normal operating mode.

OUTPUT\_CONTROL b3(ZV): This bit enables or disables the precharge function.

- 0 = ZVCHG FET is on, and is controlled by the system host (default).
- 1 = ZVCHG FET is off, and the bq29330 is in normal operating mode.

OUTPUT\_CONTROL b4 (GPOD): This bit enables or disables the GPOD output.

- 0 = GPOD is high impedance (default).
- 1 = GPOD output is active (GND).

OUTPUT\_CONTROL b5 (PMS\_CHG): This bit enables the CHG output for 0-V charge, when PMS terminal is connected to Pack.

- 0 = CHG FET is off (When PMS = GND, default).
- 1 = CHG FET is on by connecting CHG and PACK terminal. (When PMS = PACK, default).

#### STATE\_CONTROL : State control register

| STATE_CONTROL REGISTER (0x02) |   |   |      |       |       |      |       |
|-------------------------------|---|---|------|-------|-------|------|-------|
| 7                             | 6 | 5 | 4    | 3     | 2     | 1    | 0     |
| 0                             | 0 | 0 | RSNS | WDRST | WDDIS | SHIP | SLEEP |

The STATE\_CTL register controls the outputs of the bq29330 and can be used to clear certain states.

STATE\_CONTROL b0 (SLEEP): This bit is used to enter the sleep power mode.

- 0 = bq29330 exits sleep mode (default).
- 1 = bq29330 enters the sleep mode.

STATE\_CONTROL b1 (SHIP): This bit is used to enter the ship power mode when Pack supply voltage is not applied.

- 0 = bq29330 is in normal mode (default).
- 1 = bq29330 enters ship mode when pack voltage is removed.

STATE\_CONTROL b2 (WDDIS): This bit is used to enable the watchdog timer.

- 0 = Watchdog timer is enabled (default).
- 1 = Watchdog timer is disabled.

STATE\_CONTROL b3 (WDRST): This bit is used to enable the reset for GC, when watchdog timer is active.

- 0 = Reset output is disabled, when watchdog timer is active (default).
- 1 = 2 Times reset output is enabled, when watchdog timer is active.

STATE\_CONTROL b4 (RSNS): This bit sets the OL, SCC, and SCD thresholds into a range suitable for a low sense resistor value by dividing the OLV, SCCV, and SCDV selected voltage thresholds by 2.

- 0 = Current protection voltage threshold as programmed (default)
- 1 = Current protection voltage thresholds divided by 2 as programmed

STATE\_CONTROL b6..7 (0): These bits are not used and should be set to 0.

**FUNCTION\_CONTROL : Function control register**

| FUNCTION_CTL REGISTER (0x03) |   |   |   |      |     |      |      |
|------------------------------|---|---|---|------|-----|------|------|
| 7                            | 6 | 5 | 4 | 3    | 2   | 1    | 0    |
| 0                            | 0 | 0 | 0 | TOUT | BAT | PACK | VMEN |

The FUNCTION\_CONTROL register enables and disables features of the bq29330.

FUNCTION\_CONTROL b0 (VMEN): This bit enables or disables the cell and battery voltage monitoring function.

0 = Disable voltage monitoring (default). CELL output is pulled down to GND level.

1 = Enable voltage monitoring

FUNCTION\_CONTROL b1 (PACK): This bit is used to translate the PACK input to the CELL+, CELL– pins when VMEN = 1. The PACK input voltage is divided by 18 and is presented on CELL+, CELL– pins regardless of the CELL\_SEL register settings.

0 = CELL\_SEL (b0, b1) settings determine CELL+, CELL– output when VMEN = 1(default).

1 = PACK input translated to CELL output regardless of CELL\_SEL (b0, b1) selection when VMEN=1

FUNCTION\_CTL b2 (BAT): This bit is used to translate the BAT input to the CELL+, CELL– pins when VMEN=1. The VC5 input voltage is divided by 18 and is presented on CELL+, CELL– regardless of the CELL\_SEL register settings.

0 = CELL\_SEL (b0, b1) settings determine CELL+, CELL– output when VMEN = 1(default).

1 = BAT input translated to CELL+, CELL– output regardless of CELL\_SEL (b0, b1) selection when VMEN = 1

This bit priority is higher than PACK(b1).

FUNCTION\_CONTROL b3 (TOUT): This bit controls the power to the thermistor.

0 = Thermistor power is off (default).

1 = Thermistor power is on.

**CELL\_SEL : Cell select register**

| CELL_SEL REGISTER (0x04) |     |     |     |      |      |       |       |
|--------------------------|-----|-----|-----|------|------|-------|-------|
| 7                        | 6   | 5   | 4   | 3    | 2    | 1     | 0     |
| CB3                      | CB2 | CB1 | CB0 | CAL1 | CAL0 | CELL1 | CELL0 |

This register determines cell selection for voltage measurement and translation, cell balancing, and the operational mode of the cell voltage monitoring.

CELL\_SEL b0–b1 (CELL0–CELL1): These two bits select the series cell for voltage measurement translation.

| CELL1 | CELL0 | SELECTED CELL                            |
|-------|-------|------------------------------------------|
| 0     | 0     | VC4–VC5, Bottom series element (default) |
| 0     | 1     | VC4–VC3, Second lowest series element    |
| 1     | 0     | VC3–VC2, Second highest series element   |
| 1     | 1     | VC1–VC2, Top series element              |

CELL\_SEL b2–b3 (CAL1, CAL0): These bits determine the mode of the voltage monitor block

| CAL1 | CAL0 | SELECTED MODE                                                                                |
|------|------|----------------------------------------------------------------------------------------------|
| 0    | 0    | Cell translation for selected cell (default)                                                 |
| 0    | 1    | Offset measurement for selected cell                                                         |
| 1    | 0    | Monitor the VREF value for gain calibration                                                  |
| 1    | 1    | Monitor the $V_{REF}$ directly value for gain calibration, bypassing the translation circuit |

CELL\_SEL b4–b7 (CB0 – CB3): These 4 bits select the series cell for cell balance bypass path.

CELL\_SEL b4 (CB0): This bit enables or disables the bottom series cell balance charge bypass path.

0 = Disable bottom series cell balance charge bypass path (default)

1 = Enable bottom series cell balance charge bypass path

CELL\_SEL b5 (CB1): This bit enables or disables the second lowest series cell balance charge bypass path.

0 = Disable series cell balance charge bypass path (default)

1 = Enable series cell balance charge bypass path

CELL\_SEL b6 (CB2): This bit enables or disables the second highest cell balance charge bypass path.

0 = Disable series cell balance charge bypass path (default)

1 = Enable series cell balance charge bypass path

CELL\_SEL b7 (CB3): This bit enables or disables the highest series cell balance charge bypass path.

0 = Disable series cell balance charge bypass path (default)

1 = Enable series cell balance charge bypass path

#### OLV: Overload Voltage threshold register

| OLV REGISTER (0x05) |   |   |      |      |      |      |      |
|---------------------|---|---|------|------|------|------|------|
| 7                   | 6 | 5 | 4    | 3    | 2    | 1    | 0    |
| 0                   | 0 | 0 | OLV4 | OLV3 | OLV2 | OLV1 | OLV0 |

OLV (b4–b0): These four bits select the value of the overload threshold with a default of 0000.

OLV (b5–b7): These bits are not used and should be set to 0.

| OLV (b4–b0) configuration bits with corresponding voltage threshold <sup>(1)</sup> |          |      |          |      |          |      |          |
|------------------------------------------------------------------------------------|----------|------|----------|------|----------|------|----------|
| 0x00                                                                               | –0.050 V | 0x08 | –0.090 V | 0x10 | –0.130 V | 0x18 | –0.170 V |
| 0x01                                                                               | –0.055 V | 0x09 | –0.095 V | 0x11 | –0.135 V | 0x19 | –0.175 V |
| 0x02                                                                               | –0.060 V | 0x0a | –0.100 V | 0x12 | –0.140 V | 0x1a | –0.180 V |
| 0x03                                                                               | –0.065 V | 0x0b | –0.105 V | 0x13 | –0.145 V | 0x1b | –0.185 V |
| 0x04                                                                               | –0.070 V | 0x0c | –0.110 V | 0x14 | –0.150 V | 0x1c | –0.190 V |
| 0x05                                                                               | –0.075 V | 0x0d | –0.115 V | 0x15 | –0.155 V | 0x1d | –0.195 V |
| 0x06                                                                               | –0.080 V | 0x0e | –0.120 V | 0x16 | –0.160 V | 0x1e | –0.200 V |
| 0x07                                                                               | –0.085 V | 0x0f | –0.125 V | 0x17 | –0.165 V | 0x1f | –0.205 V |

(1) If RSNS bit is FUNCTION\_CONTROL = 1, then the corresponding voltage threshold is divided by 2.

**OLD: Overload Delay time configuration register**

| OLD REGISTER (0x07) |   |   |   |      |      |      |      |
|---------------------|---|---|---|------|------|------|------|
| 7                   | 6 | 5 | 4 | 3    | 2    | 1    | 0    |
| 0                   | 0 | 0 | 0 | OLD3 | OLD2 | OLD1 | OLD0 |

OLD(b3–b0): These four bits select the value of the delay time for overload with a default of 0000.

|      |      |      |       |      |       |      |       |
|------|------|------|-------|------|-------|------|-------|
| 0x00 | 1 ms | 0x04 | 9 ms  | 0x08 | 17 ms | 0x0c | 25 ms |
| 0x01 | 3 ms | 0x05 | 11 ms | 0x09 | 19 ms | 0x0d | 27 ms |
| 0x02 | 5 ms | 0x06 | 13 ms | 0x0a | 21 ms | 0x0e | 29 ms |
| 0x03 | 7 ms | 0x07 | 15 ms | 0x0b | 23 ms | 0x0f | 31 ms |

**SCC : Short Circuit In Charge configuration register**

| SCC REGISTER (0x08) |       |       |       |       |       |       |       |
|---------------------|-------|-------|-------|-------|-------|-------|-------|
| 7                   | 6     | 5     | 4     | 3     | 2     | 1     | 0     |
| SCCD3               | SCCD2 | SCCD1 | SCCD0 | SCCV3 | SCCV2 | SCCV1 | SCCV0 |

This register selects the short circuit in charge voltage threshold and delay.

SCCV (b3–b0) : These lower nibble bits select the value of the short circuit in charge voltage threshold with 0000 as the default.<sup>(1)</sup>

|      |         |      |         |      |         |      |         |
|------|---------|------|---------|------|---------|------|---------|
| 0x00 | 0.100 V | 0x04 | 0.200 V | 0x08 | 0.300 V | 0x0c | 0.400 V |
| 0x01 | 0.125 V | 0x05 | 0.225 V | 0x09 | 0.325 V | 0x0d | 0.425 V |
| 0x02 | 0.150 V | 0x06 | 0.250 V | 0x0a | 0.350 V | 0x0e | 0.450 V |
| 0x03 | 0.175 V | 0x07 | 0.275 V | 0x0b | 0.375 V | 0x0f | 0.475 V |

(1) If RSNS bit is FUNCTION\_CTL = 1, then the corresponding voltage threshold is divided by 2.

SCCD (b7–b4): These upper nibble bits select the value of the short circuit in charge delay time. Exceeding the short circuit in charge voltage threshold for longer than this period turns off the CHG and DSG outputs. 0000 is the default.

|      |             |      |             |      |             |      |             |
|------|-------------|------|-------------|------|-------------|------|-------------|
| 0x00 | 0 $\mu$ s   | 0x04 | 244 $\mu$ s | 0x08 | 488 $\mu$ s | 0x0c | 732 $\mu$ s |
| 0x01 | 61 $\mu$ s  | 0x05 | 305 $\mu$ s | 0x09 | 549 $\mu$ s | 0x0d | 793 $\mu$ s |
| 0x02 | 122 $\mu$ s | 0x06 | 366 $\mu$ s | 0x0a | 610 $\mu$ s | 0x0e | 854 $\mu$ s |
| 0x03 | 183 $\mu$ s | 0x07 | 427 $\mu$ s | 0x0b | 671 $\mu$ s | 0x0f | 915 $\mu$ s |

**SCD : Short Circuit In Discharge configuration register**

| SCD REGISTER (0x08) |       |       |       |       |       |       |       |
|---------------------|-------|-------|-------|-------|-------|-------|-------|
| 7                   | 6     | 5     | 4     | 3     | 2     | 1     | 0     |
| SCDD3               | SCDD2 | SCDD1 | SCDD0 | SCDV3 | SCDV2 | SCDV1 | SCDV0 |

This register selects the short circuit in discharge voltage threshold and delay.

SCDV(b3–b0) : These lower nibble bits select the value of the short circuit in discharge voltage threshold with 0000 as the default.<sup>(1)</sup>

|      |          |      |          |      |          |      |          |
|------|----------|------|----------|------|----------|------|----------|
| 0x00 | –0.100 V | 0x04 | –0.200 V | 0x08 | –0.300 V | 0x0c | –0.400 V |
| 0x01 | –0.125 V | 0x05 | –0.225 V | 0x09 | –0.325 V | 0x0d | –0.425 V |
| 0x02 | –0.150 V | 0x06 | –0.250 V | 0x0a | –0.350 V | 0x0e | –0.450 V |
| 0x03 | –0.175 V | 0x07 | –0.275 V | 0x0b | –0.375 V | 0x0f | –0.475 V |

(1) If RSNS bit is FUNCTION\_CTL = 1, then the corresponding voltage threshold is divided by 2.

SCCD (b7–b4): These upper nibble bits select the value of the short circuit in charge delay time. Exceeding the Short Circuit in charge voltage threshold for longer than this period will turn off the CHG and DSG outputs. 0000 is the default.

|      |             |      |             |      |             |      |             |
|------|-------------|------|-------------|------|-------------|------|-------------|
| 0x00 | 0 $\mu$ s   | 0x04 | 244 $\mu$ s | 0x08 | 488 $\mu$ s | 0x0c | 732 $\mu$ s |
| 0x01 | 61 $\mu$ s  | 0x05 | 305 $\mu$ s | 0x09 | 549 $\mu$ s | 0x0d | 793 $\mu$ s |
| 0x02 | 122 $\mu$ s | 0x06 | 366 $\mu$ s | 0x0a | 610 $\mu$ s | 0x0e | 854 $\mu$ s |
| 0x03 | 183 $\mu$ s | 0x07 | 427 $\mu$ s | 0x0b | 671 $\mu$ s | 0x0f | 915 $\mu$ s |

## REVISION HISTORY

| Changes from Original (September 2005) to Revision A                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                    | Page |
|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|
| <ul style="list-style-type: none"> <li>Changed package name From: SSOP(DBT) To: TSSOP(DBT) in the Ordering Information Table ..... 2</li> <li>Changed the SCLK pin description From: Open-drain bi-directional serial interface clock with internal 10-kΩ pullup to V<sub>REG</sub> To: Open-drain serial interface clock with internal 10-kΩ pullup to V<sub>REG</sub> ..... 4</li> <li>Changed Supply Current 2 From: XALERT, SCLK, SDATA. ZVCHG = off, Input WDI, To: XALERT, SCLK, SDATA. ZVCHG = off, WDI = 32 kHz, ..... 7</li> <li>Changed Calibration of Cell Voltage Monitor Amplifier Gain, Step 3 - From: Set CAL1=1, CAL0=1, CELL1=0, CELL0=0, VMEN=1. To: Set CAL1=1, CAL0=0, CELL1=0, CELL0=0, VMEN=1. .... 12</li> </ul> |      |
| Changes from Revision A (December 2005) to Revision B                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   | Page |
| <ul style="list-style-type: none"> <li>Deleted the QFN(RHB) package from the Ordering Information Table, the Package Option Pin Diagrams, and the Pin Functions table. .... 2</li> </ul>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                |      |
| Changes from Revision B (August 2006) to Revision C                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     | Page |
| <ul style="list-style-type: none"> <li>Changed BAT Pin description From: Charge pump, charge N-CH FET gate drive To: Device power supply input ..... 3</li> <li>Changed ELECTRICAL CHARACTERISTICS - CURRENT PROTECTION DETECTION section - positive and negative values were not properly displayed. .... 8</li> <li>Changed <a href="#">Figure 3</a> - Watchdog Timing Chart – WDI Fault at Start-up ..... 15</li> <li>Added <a href="#">Figure 4</a> - Watchdog Timing Chart – WDI Fault After Startup ..... 16</li> </ul>                                                                                                                                                                                                           |      |
| Changes from Revision C (March 2009) to Revision D                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                      | Page |
| <ul style="list-style-type: none"> <li>Added the RSM package to the Ordering Information Table ..... 2</li> <li>Added the RSM pin out package illustration. .... 3</li> </ul>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                           |      |
| Changes from Revision D (July 2009) to Revision E                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                       | Page |
| <ul style="list-style-type: none"> <li>Changed the device numbers in the Ordering Information Table From: bq29330ADBT and bq29330ARSM To: bq29330DBT and bq29330RSM ..... 2</li> <li>Added Thermal Information ..... 2</li> <li>Changed the AC Timing Requirements Table, f<sub>SCL</sub> - Clock frequency MAX value From: 400 kHz To: 100 kHz ..... 10</li> </ul>                                                                                                                                                                                                                                                                                                                                                                     |      |

**PACKAGING INFORMATION**

| Orderable Device | Status <sup>(1)</sup> | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <sup>(2)</sup> | Lead/Ball Finish | MSL Peak Temp <sup>(3)</sup> |
|------------------|-----------------------|--------------|-----------------|------|-------------|-------------------------|------------------|------------------------------|
| BQ29330DBT       | ACTIVE                | TSSOP        | DBT             | 30   | 60          | Green (RoHS & no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR          |
| BQ29330DBTG4     | ACTIVE                | TSSOP        | DBT             | 30   | 60          | Green (RoHS & no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR          |
| BQ29330DBTR      | ACTIVE                | TSSOP        | DBT             | 30   | 2000        | Green (RoHS & no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR          |
| BQ29330DBTRG4    | ACTIVE                | TSSOP        | DBT             | 30   | 2000        | Green (RoHS & no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR          |

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

**TAPE AND REEL INFORMATION**
**REEL DIMENSIONS**

**TAPE DIMENSIONS**


|    |                                                           |
|----|-----------------------------------------------------------|
| A0 | Dimension designed to accommodate the component width     |
| B0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

**TAPE AND REEL INFORMATION**

\*All dimensions are nominal

| Device      | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| BQ29330DBTR | TSSOP        | DBT             | 30   | 2000 | 330.0              | 16.4               | 6.95    | 8.3     | 1.6     | 8.0     | 16.0   | Q1            |

## TAPE AND REEL BOX DIMENSIONS

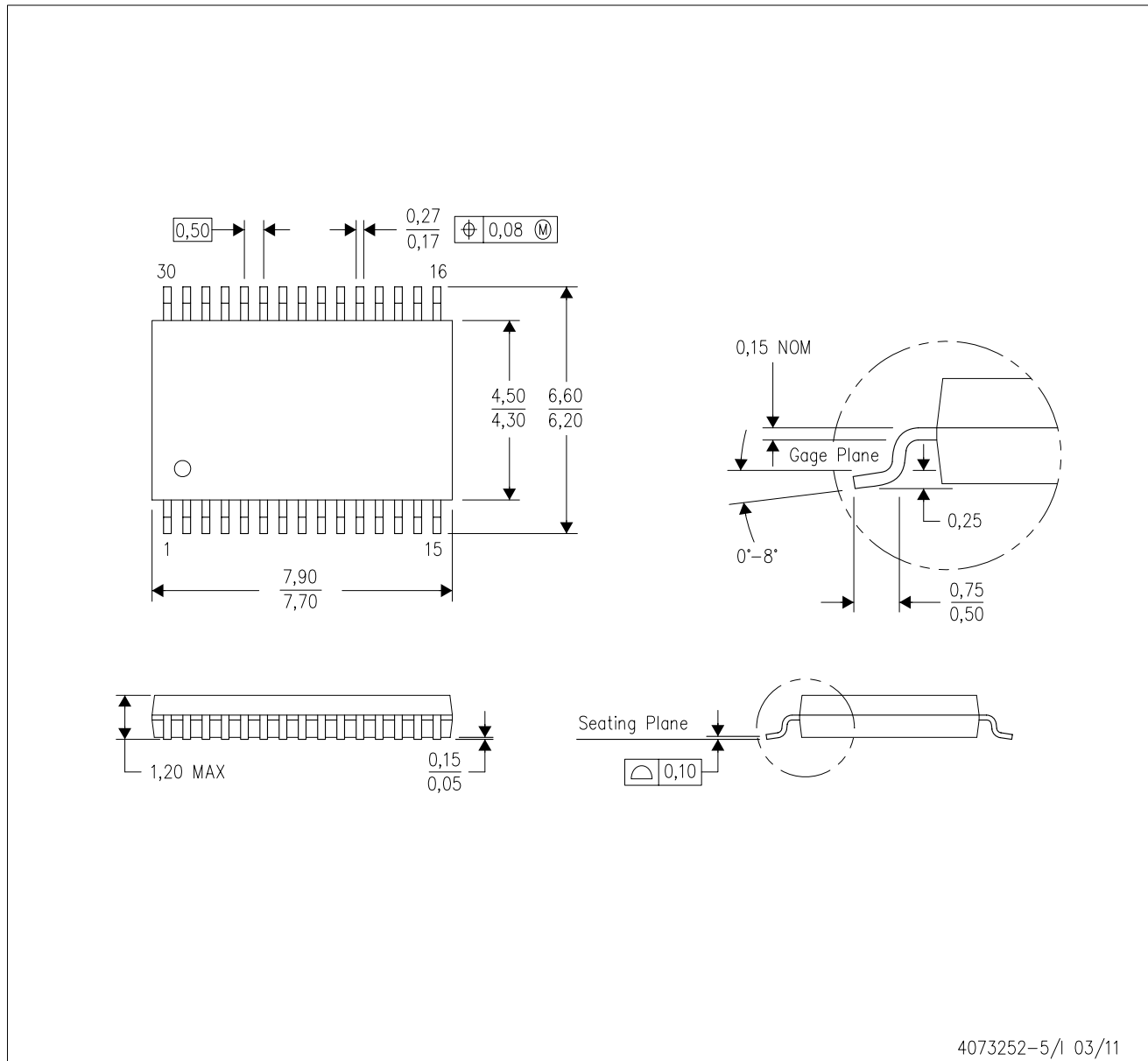


\*All dimensions are nominal

| Device      | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-------------|--------------|-----------------|------|------|-------------|------------|-------------|
| BQ29330DBTR | TSSOP        | DBT             | 30   | 2000 | 367.0       | 367.0      | 38.0        |

DBT (R-PDSO-G30)

PLASTIC SMALL OUTLINE



4073252-5/1 03/11

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - B. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold flash or protrusion.
  - D. Falls within JEDEC MO-153.

## IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46C and to discontinue any product or service per JESD48B. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have **not** been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components which meet ISO/TS16949 requirements, mainly for automotive use. Components which have not been so designated are neither designed nor intended for automotive use; and TI will not be responsible for any failure of such components to meet such requirements.

### Products

|                        |                                                                                      |
|------------------------|--------------------------------------------------------------------------------------|
| Audio                  | <a href="http://www.ti.com/audio">www.ti.com/audio</a>                               |
| Amplifiers             | <a href="http://amplifier.ti.com">amplifier.ti.com</a>                               |
| Data Converters        | <a href="http://dataconverter.ti.com">dataconverter.ti.com</a>                       |
| DLP® Products          | <a href="http://www.dlp.com">www.dlp.com</a>                                         |
| DSP                    | <a href="http://dsp.ti.com">dsp.ti.com</a>                                           |
| Clocks and Timers      | <a href="http://www.ti.com/clocks">www.ti.com/clocks</a>                             |
| Interface              | <a href="http://interface.ti.com">interface.ti.com</a>                               |
| Logic                  | <a href="http://logic.ti.com">logic.ti.com</a>                                       |
| Power Mgmt             | <a href="http://power.ti.com">power.ti.com</a>                                       |
| Microcontrollers       | <a href="http://microcontroller.ti.com">microcontroller.ti.com</a>                   |
| RFID                   | <a href="http://www.ti-rfid.com">www.ti-rfid.com</a>                                 |
| OMAP Mobile Processors | <a href="http://www.ti.com/omap">www.ti.com/omap</a>                                 |
| Wireless Connectivity  | <a href="http://www.ti.com/wirelessconnectivity">www.ti.com/wirelessconnectivity</a> |

### Applications

|                               |                                                                                          |
|-------------------------------|------------------------------------------------------------------------------------------|
| Automotive and Transportation | <a href="http://www.ti.com/automotive">www.ti.com/automotive</a>                         |
| Communications and Telecom    | <a href="http://www.ti.com/communications">www.ti.com/communications</a>                 |
| Computers and Peripherals     | <a href="http://www.ti.com/computers">www.ti.com/computers</a>                           |
| Consumer Electronics          | <a href="http://www.ti.com/consumer-apps">www.ti.com/consumer-apps</a>                   |
| Energy and Lighting           | <a href="http://www.ti.com/energy">www.ti.com/energy</a>                                 |
| Industrial                    | <a href="http://www.ti.com/industrial">www.ti.com/industrial</a>                         |
| Medical                       | <a href="http://www.ti.com/medical">www.ti.com/medical</a>                               |
| Security                      | <a href="http://www.ti.com/security">www.ti.com/security</a>                             |
| Space, Avionics and Defense   | <a href="http://www.ti.com/space-avionics-defense">www.ti.com/space-avionics-defense</a> |
| Video and Imaging             | <a href="http://www.ti.com/video">www.ti.com/video</a>                                   |

**TI E2E Community** [e2e.ti.com](http://e2e.ti.com)